



(51) International Patent Classification:

G06F 3/042 (2006.01) G06F 3/0354 (2013.01)

(21) International Application Number:

PCT/IB2017/000699

(22) International Filing Date:

23 May 2017 (23.05.2017)

(25) Filing Language:

English

(26) Publication Language:

English

(30) Priority Data:

62/340,474 23 May 2016 (23.05.2016) US

(71) Applicant: RAPT IP LIMITED [MT/MT]; Vision Exchange Building, Territorials Street, Mriehel Bkr, 3000 (MT).

(72) Inventor: DRUMM, Owen; C/o Rapt Ip Limited, Vision Exchange Building, Territorials Street, Mriehel, Bkr, 3000 (MT).

(81) Designated States (unless otherwise indicated, for every kind of national protection available): AE, AG, AL, AM, AO, AT, AU, AZ, BA, BB, BG, BH, BN, BR, BW, BY, BZ, CA, CH, CL, CN, CO, CR, CU, CZ, DE, DJ, DK, DM, DO, DZ, EC, EE, EG, ES, FI, GB, GD, GE, GH, GM, GT, HN, HR, HU, ID, IL, IN, IR, IS, JP, KE, KG, KH, KN, KP, KR, KW, KZ, LA, LC, LK, LR, LS, LU, LY, MA, MD, ME, MG,

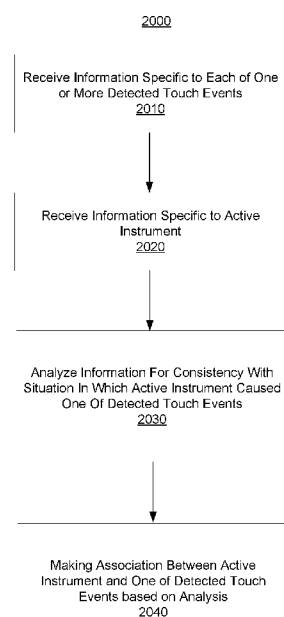
MK, MN, MW, MX, MY, MZ, NA, NG, NI, NO, NZ, OM, PA, PE, PG, PH, PL, PT, QA, RO, RS, RU, RW, SA, SC, SD, SE, SG, SK, SL, SM, ST, SV, SY, TH, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, ZA, ZM, ZW.

(84) Designated States (unless otherwise indicated, for every kind of regional protection available): ARIPO (BW, GH, GM, KE, LR, LS, MW, MZ, NA, RW, SD, SL, ST, SZ, TZ, UG, ZM, ZW), Eurasian (AM, AZ, BY, KG, KZ, RU, TJ, TM), European (AL, AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HR, HU, IE, IS, IT, LT, LU, LV, MC, MK, MT, NL, NO, PL, PT, RO, RS, SE, SI, SK, SM, TR), OAPI (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, KM, ML, MR, NE, SN, TD, TG).

Published:

- with international search report (Art. 21(3))
- before the expiration of the time limit for amending the claims and to be republished in the event of receipt of amendments (Rule 48.2(h))

(54) Title: INSTRUMENT DETECTION WITH AN OPTICAL TOUCH SENSITIVE DEVICE, WITH ASSOCIATING CONTACTS WITH ACTIVE INSTRUMENTS



(57) Abstract: An optical touch-sensitive device detects touch events caused by instalments (e.g., pens, styluses) and distinguishes these events from touch events caused by fingers. In some embodiments, different instruments can also be distinguished. The optical touch-sensitive device includes multiple emitters and detectors. Each emitter produces optical beams which are received by the detectors. The optical beams preferably are multiplexed in a manner so that many optical beams can be received by a detector simultaneously. Touch events disturb the optical beams, for example due to frustrated total internal reflection. Information indicating which optical beams have been disturbed is analyzed to detect one or more touch events. The analysis also distinguishes instrument touch events from finger touch events.

FIG. 20

INSTRUMENT DETECTION WITH AN OPTICAL TOUCH SENSITIVE DEVICE, WITH ASSOCIATING CONTACTS WITH ACTIVE INSTRUMENTS

INVENTORS:

OWEN DRUMM

CROSS-REFERENCE TO RELATED APPLICATION(S)

[0001] This application claims priority under 35 U.S.C. § 119(e) to U.S. Provisional Patent Application Serial No. 62/340,474, “Associating Contacts with Active Instruments,” filed May 23, 2016, the subject matter of which is incorporated herein by reference in its entirety.

BACKGROUND

1. Field of Art

[0002] This invention generally relates to detecting touch events in a touch-sensitive device.

2. Description of the Related Art

[0003] Touch-sensitive displays for interacting with computing devices are becoming more common. A number of different technologies exist for implementing touch-sensitive displays and other touch-sensitive devices. Examples of these techniques include, for example, resistive touch screens, surface acoustic wave touch screens, capacitive touch screens and certain types of optical touch screens.

[0004] However, many of these approaches currently suffer from drawbacks. For example, some technologies may function well for small sized displays, as used in many modern mobile phones, but do not scale well to larger screen sizes as in displays used with laptop or even desktop computers. For technologies that require a specially processed surface or the use of special elements in the surface, increasing the screen size by a linear factor of N means that the special processing must be scaled to handle the N^2 larger area of the screen or that N^2 times as many special elements are required. This can result in unacceptably low yields or prohibitively high costs.

[0005] Another drawback for some technologies is their inability or difficulty in handling multitouch events. A multitouch event occurs when multiple touch events occur

simultaneously. This can introduce ambiguities in the raw detected signals, which then must be resolved. Importantly, the ambiguities must be resolved in a speedy and computationally efficient manner. If too slow, then the technology will not be able to deliver the touch sampling rate required by the system. If too computationally intensive, then this will drive up the cost and power consumption of the technology.

[0006] Another drawback is that technologies may not be able to meet increasing resolution demands. Assume that the touch-sensitive surface is rectangular with length and width dimensions $L \times W$. Further assume that an application requires that touch points be located with an accuracy of δl and δw , respectively. The effective required resolution is then $R = (L \times W) / (\delta l \times \delta w)$. We will express R as the effective number of touch points. As technology progresses, the numerator in R generally will increase and the denominator generally will decrease, thus leading to an overall increasing trend for the required touch resolution R .

[0007] Thus, there is a need for improved touch-sensitive systems.

SUMMARY

[0008] An optical touch-sensitive device detects touch events caused by instruments (e.g., pens, styluses) and distinguishes these events from touch events caused by fingers. In some embodiments, different instruments can also be distinguished.

[0009] The optical touch-sensitive device includes multiple emitters and detectors. Each emitter produces optical beams which are received by the detectors. The optical beams preferably are multiplexed in a manner so that many optical beams can be received by a detector simultaneously. Touch events disturb the optical beams, for example due to frustrated total internal reflection. Information indicating which optical beams have been disturbed is analyzed to detect one or more touch events. The analysis also distinguishes instrument touch events from finger touch events.

[0010] Instruments can be distinguished from fingers on many different bases. One example is contact area. This can include size, shape and asymmetry of the contact area. The contact area for instruments can also be designed to include multiple disjoint regions. Another example is attenuation rates. Instruments can be constructed from materials which will exhibit a higher attenuation rate than fingers. Temporal behavior can also be used. A finger contacting a surface typically has a different temporal aspect than an instrument

contacting a surface. The actual instrument response, with respect to attenuating or enhancing optical beams, can also be engineered to be different than that caused by fingers. Because instruments are manufactured, a much larger variety of responses can be implemented, including redirecting incoming optical beams to different directions and splitting incoming optical beams into multiple outgoing optical beams. Wavelength is yet another degree of freedom that can be used to distinguish instruments, both from fingers and from other instruments.

[0011] Active instruments can include the use of emitters and detectors. Emitters can inject additional optical beams into the system. These additional optical beams can be used to detect the presence of the instrument. They can also be designed to identify the instrument. They can also be used as a separate communication channel from the instrument. Detectors can be used in the reverse direction. Optical beams created by emitters on the periphery can be detected and this can be used to detect the presence of the instrument. Detected optical beams can also be used as a communication channel to the instrument. Some instruments may also have additional out of band communications, such as through a wireless channel.

[0012] Other modalities may also be used to detect instrument touch events. Examples include palm touches and acoustics. Since an instrument is held in the user's hand, an instrument touch event is often accompanied by a palm touch in the vicinity. This can be used to help identify instrument touch events. Acoustic or vibration information can also be used to distinguish instrument touch events from finger touch events, due to their different acoustic and vibration signatures.

[0013] Other aspects include components, devices, systems, improvements, methods, processes, applications, computer readable mediums, and other technologies related to any of the above.

BRIEF DESCRIPTION OF DRAWINGS

[0014] Embodiments of the present invention will now be described, by way of example, with reference to the accompanying drawings, in which:

[0015] FIG. 1 is a diagram of an optical touch-sensitive device, according to one embodiment.

[0016] FIG. 2 is a flow diagram for determining the locations of touch events, according to one embodiment.

- [0017] FIGs. 3A-3F illustrate different mechanisms for a touch interaction with an optical beam.
- [0018] FIG. 4 are graphs of binary and analog touch interactions.
- [0019] FIGs. 5A-5C are top views of differently shaped beam footprints.
- [0020] FIGs. 6A-6B are top views illustrating a touch point travelling through a narrow beam and a wide beam, respectively.
- [0021] FIG. 7 are graphs of the binary and analog responses for the narrow and wide beams of FIG. 6.
- [0022] FIGs. 8A-8B are top views illustrating active area coverage by emitters.
- [0023] FIG. 8C is a top view illustrating alternating emitters and detectors.
- [0024] FIGs. 9A-9E are top views of different types of two-dimensional contact areas for instruments.
- [0025] FIG. 10A illustrates a finger touch progressing in time.
- [0026] FIGs. 10B and 10C illustrate instrument touches progressing in time.
- [0027] FIG. 10D is a graph of the transmission coefficient T_{jk} of the optical beams passing under the center of a touch contact.
- [0028] FIG. 10E is a graph of the transmission coefficient T_{jk} of the optical beams passing under the center of a touch contact before, during, and after a touch event.
- [0029] FIG. 11 is a diagram of nomenclature used to define an instrument response.
- [0030] FIGs. 12A-12B are a front view and a side cross-sectional view of a tip structure using internal waveguide channels.
- [0031] FIG. 12C illustrates operation of the tip structure in FIGs. 12A-12B.
- [0032] FIG. 13 is a diagram of a tip structure that redirects light.
- [0033] FIG. 14 is a diagram of a wavelength-selective tip structure.
- [0034] FIG. 15 is a diagram of a tip structure using a grating.
- [0035] FIG. 16 is a diagram of a tip structure with an intermediate index of refraction.
- [0036] FIG. 17A is a side view of an injector tip.
- [0037] FIGs 17B-17D are top view of different types of injector tips.
- [0038] FIGs. 18A-18E are different types of active instruments.
- [0039] FIG. 19A illustrates a time-varying emission pattern.
- [0040] FIGs. 19B-19C illustrate implementation of an emission pattern in an active instrument.

[0041] FIG. 20 is a flow diagram for making an association between an active instrument and a detected touch event.

[0042] FIGs. 21A-21C illustrate associating an active instrument with a detected touch event based on transmittance of optical beams.

[0043] FIGs. 22A-22C illustrate associating an active instrument with a detected touch event based on movement of the active instrument and detected touch event.

[0044] FIGs. 23A-23D illustrate associating an active instrument with a detected touch event based on emission pattern of the active instrument.

[0045] FIG. 24 illustrates distinguishing two active instruments that have the same emission pattern.

[0046] FIGs. 25A-25B are examples of coupling injected light of an active instrument into a touch-sensitive device using a total-internal-reflection-based active instrument.

[0047] FIG. 26 is a flow diagram for qualifying possible instrument touches.

DETAILED DESCRIPTION

[0048] This detailed description is divided into two parts. Part A provides a description of various aspects of touch-sensitive systems and the detection of multitouch events. These are described in the context of finger touches, but the concepts apply also to instrument (e.g., pen or stylus) touches. Part B provides a description of detecting instrument touches, including distinguishing between different types of instruments. The following is the contents of the detailed description:

Part A: Touch Detection

- I. Introduction
- II. Physical Set-up
- III. Processing Phase

Part B: Instrument Detection

- IV. Introduction
- V. Passive Instrument Detection
- VI. Active Instrument Detection
- VII. Additional Modalities

PART A: TOUCH DETECTION

I. Introduction

A. Device Overview

[0049] FIG. 1 is a diagram of an optical touch-sensitive device 100, according to one embodiment. The optical touch-sensitive device 100 includes a controller 110, emitter/detector drive circuits 120, and a touch-sensitive surface assembly 130. The surface assembly 130 includes a surface 131 over which touch events are to be detected. For convenience, the area defined by surface 131 may sometimes be referred to as the active area or active surface, even though the surface itself may be an entirely passive structure. The assembly 130 also includes emitters and detectors arranged along the periphery of the active surface 131. In this example, there are J emitters labeled as Ea-EJ and K detectors labeled as D1-DK. The device also includes a touch event processor 140, which may be implemented as part of the controller 110 or separately as shown in FIG. 1. A standardized API may be used to communicate with the touch event processor 140, for example between the touch event processor 140 and controller 110, or between the touch event processor 140 and other devices connected to the touch event processor.

[0050] The emitter/detector drive circuits 120 serve as an interface between the controller 110 and the emitters Ej and detectors Dk. The emitters produce optical “beams” which are received by the detectors. Preferably, the light produced by one emitter is received by more than one detector, and each detector receives light from more than one emitter. For convenience, “beam” will refer to the light from one emitter to one detector, even though it may be part of a large fan of light that goes to many detectors rather than a separate beam. The beam from emitter Ej to detector Dk will be referred to as beam jk. FIG. 1 expressly labels beams a1, a2, a3, e1 and eK as examples. Touches within the active area 131 will disturb certain beams, thus changing what is received at the detectors Dk. Data about these changes is communicated to the touch event processor 140, which analyzes the data to determine the location(s) (and times) of touch events on surface 131.

[0051] One advantage of an optical approach as shown in FIG. 1 is that this approach scales well to larger screen sizes. Since the emitters and detectors are positioned around the periphery, increasing the screen size by a linear factor of N means that the periphery also scales by a factor of N rather than N^2 .

[0052] These touch-sensitive devices can be used in various applications. Touch-sensitive displays are one class of application. This includes displays for tablets, laptops, desktops, gaming consoles, smart phones and other types of compute devices. It also includes displays for TVs, digital signage, public information, whiteboards, e-readers and

other types of good resolution displays. However, they can also be used on smaller or lower resolution displays: simpler cell phones, user controls (photocopier controls, printer controls, control of appliances, etc.). These touch-sensitive devices can also be used in applications other than displays. The “surface” over which the touches are detected could be a passive element, such as a printed image or simply some hard surface. This application could be used as a user interface, similar to a trackball or mouse.

B. Process Overview

[0053] FIG. 2 is a flow diagram for determining the locations of touch events, according to one embodiment. This process will be illustrated using the device of FIG. 1. The process 200 is roughly divided into two phases, which will be referred to as a physical phase 210 and a processing phase 220. Conceptually, the dividing line between the two phases is a set of transmission coefficients T_{jk} .

[0054] The transmission coefficient T_{jk} is the transmittance of the optical beam from emitter j to detector k , compared to what would have been transmitted if there was no touch event interacting with the optical beam. In the following examples, we will use a scale of 0 (fully blocked beam) to 1 (fully transmitted beam). Thus, a beam jk that is undisturbed by a touch event has $T_{jk} = 1$. A beam jk that is fully blocked by a touch event has a $T_{jk} = 0$. A beam jk that is partially blocked or attenuated by a touch event has $0 < T_{jk} < 1$. It is possible for $T_{jk} > 1$, for example depending on the nature of the touch interaction or in cases where light is deflected or scattered to detectors k that it normally would not reach.

[0055] The use of this specific measure is purely an example. Other measures can be used. In particular, since we are most interested in interrupted beams, an inverse measure such as $(1 - T_{jk})$ may be used since it is normally 0. Other examples include measures of absorption, attenuation, reflection or scattering. In addition, although FIG. 2 is explained using T_{jk} as the dividing line between the physical phase 210 and the processing phase 220, it is not required that T_{jk} be expressly calculated. Nor is a clear division between the physical phase 210 and processing phase 220 required.

[0056] Returning to FIG. 2, the physical phase 210 is the process of determining the T_{jk} from the physical setup. The processing phase 220 determines the touch events from the T_{jk} . The model shown in FIG. 2 is conceptually useful because it somewhat separates the physical setup and underlying physical mechanisms from the subsequent processing.

[0057] For example, the physical phase 210 produces transmission coefficients T_{jk} . Many different physical designs for the touch-sensitive surface assembly 130 are possible,

and different design tradeoffs will be considered depending on the end application. For example, the emitters and detectors may be narrower or wider, narrower angle or wider angle, various wavelengths, various powers, coherent or not, etc. As another example, different types of multiplexing may be used to allow beams from multiple emitters to be received by each detector. Several of these physical setups and manners of operation are described below, primarily in Section II.

[0058] The interior of block 210 shows one possible implementation of process 210. In this example, emitters transmit 212 beams to multiple detectors. Some of the beams travelling across the touch-sensitive surface are disturbed by touch events. The detectors receive 214 the beams from the emitters in a multiplexed optical form. The received beams are de-multiplexed 216 to distinguish individual beams j_k from each other. Transmission coefficients T_{jk} for each individual beam j_k are then determined 218.

[0059] The processing phase 220 can also be implemented in many different ways. Candidate touch points, line imaging, location interpolation, touch event templates and multi-pass approaches are all examples of techniques that may be used as part of the processing phase 220. Several of these are described below, primarily in Section III.

II. Physical Set-up

[0060] The touch-sensitive device 100 may be implemented in a number of different ways. The following are some examples of design variations.

A. Electronics

[0061] With respect to electronic aspects, note that FIG. 1 is exemplary and functional in nature. Functions from different boxes in FIG. 1 can be implemented together in the same component.

[0062] For example, the controller 110 and touch event processor 140 may be implemented as hardware, software or a combination of the two. They may also be implemented together (e.g., as an SoC with code running on a processor in the SoC) or separately (e.g., the controller as part of an ASIC, and the touch event processor as software running on a separate processor chip that communicates with the ASIC). Example implementations include dedicated hardware (e.g., ASIC or programmed field programmable gate array (FPGA)), and microprocessor or microcontroller (either embedded or standalone) running software code (including firmware). Software implementations can be modified after manufacturing by updating the software.

[0063] The emitter/detector drive circuits 120 serve as an interface between the controller 110 and the emitters and detectors. In one implementation, the interface to the controller 110 is at least partly digital in nature. With respect to emitters, the controller 110 may send commands controlling the operation of the emitters. These commands may be instructions, for example a sequence of bits which mean to take certain actions: start/stop transmission of beams, change to a certain pattern or sequence of beams, adjust power, power up/power down circuits. They may also be simpler signals, for example a “beam enable signal,” where the emitters transmit beams when the beam enable signal is high and do not transmit when the beam enable signal is low.

[0064] The circuits 120 convert the received instructions into physical signals that drive the emitters. For example, circuit 120 might include some digital logic coupled to digital to analog converters, in order to convert received digital instructions into drive currents for the emitters. The circuit 120 might also include other circuitry used to operate the emitters: modulators to impress electrical modulations onto the optical beams (or onto the electrical signals driving the emitters), control loops and analog feedback from the emitters, for example. The emitters may also send information to the controller, for example providing signals that report on their current status.

[0065] With respect to the detectors, the controller 110 may also send commands controlling the operation of the detectors, and the detectors may return signals to the controller. The detectors also transmit information about the beams received by the detectors. For example, the circuits 120 may receive raw or amplified analog signals from the detectors. The circuits then may condition these signals (e.g., noise suppression), convert them from analog to digital form, and perhaps also apply some digital processing (e.g., demodulation).

B. Touch Interactions

[0066] FIGs. 3A-3F illustrate different mechanisms for a touch interaction with an optical beam. FIG. 3A illustrates a mechanism based on frustrated total internal reflection (TIR). The optical beam, shown as a dashed line, travels from emitter E to detector D through an optically transparent planar waveguide 302. The beam is confined to the waveguide 302 by total internal reflection. The waveguide may be constructed of plastic or glass, for example. An object 304, such as a finger or stylus, coming into contact with the transparent waveguide 302, has a higher refractive index than the air normally surrounding the waveguide. Over the area of contact, the increase in the refractive index due to the object

disturbs the total internal reflection of the beam within the waveguide. The disruption of total internal reflection increases the light leakage from the waveguide, attenuating any beams passing through the contact area. Correspondingly, removal of the object 304 will stop the attenuation of the beams passing through. Attenuation of the beams passing through the touch point will result in less power at the detectors, from which the reduced transmission coefficients T_{jk} can be calculated.

[0067] FIG. 3B illustrates a mechanism based on beam blockage. Emitters produce beams which are in close proximity to a surface 306. An object 304 coming into contact with the surface 306 will partially or entirely block beams within the contact area. FIGs. 3A and 3B illustrate some physical mechanisms for touch interactions, but other mechanisms can also be used. For example, the touch interaction may be based on changes in polarization, scattering, or changes in propagation direction or propagation angle (either vertically or horizontally).

[0068] For example, FIG. 3C illustrates a different mechanism based on propagation angle. In this example, the optical beam is guided in a waveguide 302 via TIR. The optical beam hits the waveguide-air interface at a certain angle and is reflected back at the same angle. However, the touch 304 changes the angle at which the optical beam is propagating. In FIG. 3C, the optical beam travels at a steeper angle of propagation after the touch 304. The detector D has a response that varies as a function of the angle of propagation. The detector D could be more sensitive to the optical beam travelling at the original angle of propagation or it could be less sensitive. Regardless, an optical beam that is disturbed by a touch 304 will produce a different response at detector D.

[0069] In FIGs. 3A-3C, the touching object was also the object that interacted with the beam. This will be referred to as a direct interaction. In an indirect interaction, the touching object interacts with an intermediate object, which interacts with the optical beam. FIG. 3D shows an example that uses intermediate blocking structures 308. Normally, these structures 308 do not block the beam. However, in FIG. 3D, object 304 contacts the blocking structure 308, which causes it to partially or entirely block the optical beam. In FIG. 3D, the structures 308 are shown as discrete objects, but they do not have to be so.

[0070] In FIG. 3E, the intermediate structure 310 is a compressible, partially transmitting sheet. When there is no touch, the sheet attenuates the beam by a certain amount. In FIG. 3E, the touch 304 compresses the sheet, thus changing the attenuation of the beam. For example, the upper part of the sheet may be more opaque than the lower part, so

that compression decreases the transmittance. Alternately, the sheet may have a certain density of scattering sites. Compression increases the density in the contact area, since the same number of scattering sites occupies a smaller volume, thus decreasing the transmittance. Analogous indirect approaches can also be used for frustrated TIR. Note that this approach could be used to measure contact pressure or touch velocity, based on the degree or rate of compression.

[0071] The touch mechanism may also enhance transmission, instead of or in addition to reducing transmission. For example, the touch interaction in FIG. 3E might increase the transmission instead of reducing it. The upper part of the sheet may be more transparent than the lower part, so that compression increases the transmittance.

[0072] FIG. 3F shows another example where the transmittance between an emitter and detector increases due to a touch interaction. FIG. 3F is a top view. Emitter Ea normally produces a beam that is received by detector D1. When there is no touch interaction, $Ta1 = 1$ and $Ta2 = 0$. However, a touch interaction 304 blocks the beam from reaching detector D1 and scatters some of the blocked light to detector D2. Thus, detector D2 receives more light from emitter Ea than it normally would. Accordingly, when there is a touch event 304, $Ta1$ decreases and $Ta2$ increases.

[0073] As will be described in detail in Part B, if the object 304 is an instrument, the instrument can be designed to have certain touch interaction characteristics. For example, the touch interaction caused by the instrument 304 may vary as a function of wavelength, or the interaction may change as the instrument is tilted, translated, rotated or otherwise moved. The touch interaction with the instrument 304 may also depend on the propagation direction of the optical beam. The instrument 304 may also be an active device, with its own emitter(s) and/or detector(s). It may also include re-emitter(s), which detect incoming optical beams and then re-emit the beams, possibly changing the beams before re-emission.

[0074] For simplicity, in the remainder of this Part A, the touch mechanism will be assumed to be primarily of a blocking nature, meaning that a beam from an emitter to a detector will be partially or fully blocked by an intervening touch event. This is not required, but it is convenient to illustrate various concepts.

[0075] For convenience, the touch interaction mechanism may sometimes be classified as either binary or analog. A binary interaction is one that basically has two possible responses as a function of the touch. Examples includes non-blocking and fully blocking, or non-blocking and 10%+ attenuation, or not frustrated and frustrated TIR. An analog

interaction is one that has a “grayscale” response to the touch: non-blocking passing through gradations of partially blocking to blocking. Whether the touch interaction mechanism is binary or analog depends in part on the nature of the interaction between the touch and the beam. It does not depend on the lateral width of the beam (which can also be manipulated to obtain a binary or analog attenuation, as described below), although it might depend on the vertical size of the beam.

[0076] FIG. 4 is a graph illustrating a binary touch interaction mechanism compared to an analog touch interaction mechanism. FIG. 4 graphs the transmittance T_{jk} as a function of the depth z of the touch. The dimension z is into and out of the active surface. Curve 410 is a binary response. At low z (i.e., when the touch has not yet disturbed the beam), the transmittance T_{jk} is at its maximum. However, at some point z_0 , the touch breaks the beam and the transmittance T_{jk} falls fairly suddenly to its minimum value. Curve 420 shows an analog response where the transition from maximum T_{jk} to minimum T_{jk} occurs over a wider range of z . If curve 420 is well behaved, it is possible to estimate z from the measured value of T_{jk} .

C. Emitters, Detectors and Couplers

[0077] Each emitter transmits light to a number of detectors. Usually, each emitter outputs light to more than one detector simultaneously. Similarly, each detector receives light from a number of different emitters. The optical beams may be visible, infrared and/or ultraviolet light. The term “light” is meant to include all of these wavelengths and terms such as “optical” are to be interpreted accordingly.

[0078] Examples of the optical sources for the emitters include light emitting diodes (LEDs) and semiconductor lasers. IR sources can also be used. Modulation of optical beams can be achieved by directly modulating the optical source or by using an external modulator, for example a liquid crystal modulator or a deflected mirror modulator. Examples of sensor elements for the detector include charge coupled devices, photodiodes, photoresistors, phototransistors, and nonlinear all-optical detectors. Typically, the detectors output an electrical signal that is a function of the intensity of the received optical beam.

[0079] The emitters and detectors may also include optics and/or electronics in addition to the main optical source and sensor element. For example, optics can be used to couple between the emitter/detector and the desired beam path. Optics can also reshape or otherwise condition the beam produced by the emitter or accepted by the detector. These optics may

include lenses, Fresnel lenses, mirrors, filters, non-imaging optics and other optical components.

[0080] In this disclosure, the optical paths will be shown unfolded for clarity. Thus, sources, optical beams and sensors will be shown as lying in one plane. In actual implementations, the sources and sensors typically will not lie in the same plane as the optical beams. Various coupling approaches can be used. A planar waveguide or optical fiber may be used to couple light to/from the actual beam path. Free space coupling (e.g., lenses and mirrors) may also be used. A combination may also be used, for example waveguided along one dimension and free space along the other dimension. Various coupler designs are described in U.S. Application Serial No. 61/510,989 “Optical Coupler” filed on July 22, 2011, which is incorporated by reference in its entirety herein.

D. Optical Beam Paths

[0081] Another aspect of a touch-sensitive system is the shape and location of the optical beams and beam paths. In FIGs. 1-2, the optical beams are shown as lines. These lines should be interpreted as representative of the beams, but the beams themselves are not necessarily narrow pencil beams. FIGs. 5A-5C illustrate different beam shapes.

[0082] FIG. 5A shows a point emitter E, point detector D and a narrow “pencil” beam 510 from the emitter to the detector. In FIG. 5B, a point emitter E produces a fan-shaped beam 520 received by the wide detector D. In FIG. 5C, a wide emitter E produces a “rectangular” beam 530 received by the wide detector D. These are top views of the beams and the shapes shown are the footprints of the beam paths. Thus, beam 510 has a line-like footprint, beam 520 has a triangular footprint which is narrow at the emitter and wide at the detector, and beam 530 has a fairly constant width rectangular footprint. In FIG. 5, the detectors and emitters are represented by their widths, as seen by the beam path. The actual optical sources and sensors may not be so wide. Rather, optics (e.g., cylindrical lenses or mirrors) can be used to effectively widen or narrow the lateral extent of the actual sources and sensors.

[0083] FIGs. 6A-6B and 7 show how the width of the footprint can determine whether the transmission coefficient T_{jk} behaves as a binary or analog quantity. In these figures, a touch point has contact area 610. Assume that the touch is fully blocking, so that any light that hits contact area 610 will be blocked. FIG. 6A shows what happens as the touch point moves left to right past a narrow beam. In the leftmost situation, the beam is not blocked at all (i.e., maximum T_{jk}) until the right edge of the contact area 610 interrupts the beam. At

this point, the beam is fully blocked (i.e., minimum T_{jk}), as is also the case in the middle scenario. It continues as fully blocked until the entire contact area moves through the beam. Then, the beam is again fully unblocked, as shown in the righthand scenario. Curve 710 in FIG. 7 shows the transmittance T_{jk} as a function of the lateral position x of the contact area 610. The sharp transitions between minimum and maximum T_{jk} show the binary nature of this response.

[0084] FIG. 6B shows what happens as the touch point moves left to right past a wide beam. In the leftmost scenario, the beam is just starting to be blocked. The transmittance T_{jk} starts to fall off but is at some value between the minimum and maximum values. The transmittance T_{jk} continues to fall as the touch point blocks more of the beam, until the middle situation where the beam is fully blocked. Then the transmittance T_{jk} starts to increase again as the contact area exits the beam, as shown in the righthand situation. Curve 720 in FIG. 7 shows the transmittance T_{jk} as a function of the lateral position x of the contact area 610. The transition over a broad range of x shows the analog nature of this response.

[0085] FIGs. 5-7 consider an individual beam path. In most implementations, each emitter and each detector will support multiple beam paths.

[0086] FIG. 8A is a top view illustrating the beam pattern produced by a point emitter. Emitter E_j transmits beams to wide detectors D1-DK. Three beams are shaded for clarity: beam j_1 , beam $j(K-1)$ and an intermediate beam. Each beam has a fan-shaped footprint. The aggregate of all footprints is emitter E_j 's coverage area. That is, any touch event that falls within emitter E_j 's coverage area will disturb at least one of the beams from emitter E_j . FIG. 8B is a similar diagram, except that emitter E_j is a wide emitter and produces beams with "rectangular" footprints (actually, trapezoidal but we will refer to them as rectangular). The three shaded beams are for the same detectors as in FIG. 8A.

[0087] Note that every emitter E_j may not produce beams for every detector D_k . In FIG. 1, consider beam path a_K which would go from emitter E_a to detector DK. First, the light produced by emitter E_a may not travel in this direction (i.e., the radiant angle of the emitter may not be wide enough) so there may be no physical beam at all, or the acceptance angle of the detector may not be wide enough so that the detector does not detect the incident light. Second, even if there was a beam and it was detectable, it may be ignored because the beam path is not located in a position to produce useful information. Hence, the transmission coefficients T_{jk} may not have values for all combinations of emitters E_j and detectors D_k .

[0088] The footprints of individual beams from an emitter and the coverage area of all beams from an emitter can be described using different quantities. Spatial extent (i.e., width), angular extent (i.e., radiant angle for emitters, acceptance angle for detectors) and footprint shape are quantities that can be used to describe individual beam paths as well as an individual emitter's coverage area.

[0089] An individual beam path from one emitter E_j to one detector D_k can be described by the emitter E_j 's width, the detector D_k 's width and/or the angles and shape defining the beam path between the two.

[0090] These individual beam paths can be aggregated over all detectors for one emitter E_j to produce the coverage area for emitter E_j . Emitter E_j 's coverage area can be described by the emitter E_j 's width, the aggregate width of the relevant detectors D_k and/or the angles and shape defining the aggregate of the beam paths from emitter E_j . Note that the individual footprints may overlap (see FIG. 8B close to the emitter). Therefore an emitter's coverage area may not be equal to the sum of its footprints. The ratio of (the sum of an emitter's footprints) / (emitter's cover area) is one measure of the amount of overlap.

[0091] The coverage areas for individual emitters can be aggregated over all emitters to obtain the overall coverage for the system. In this case, the shape of the overall coverage area is not so interesting because it should cover the entirety of the active area 131. However, not all points within the active area 131 will be covered equally. Some points may be traversed by many beam paths while other points traversed by far fewer. The distribution of beam paths over the active area 131 may be characterized by calculating how many beam paths traverse different (x,y) points within the active area. The orientation of beam paths is another aspect of the distribution. An (x,y) point that is derived from three beam paths that are all running roughly in the same direction usually will be a weaker distribution than a point that is traversed by three beam paths that all run at 60 degree angles to each other.

[0092] The discussion above for emitters also holds for detectors. The diagrams constructed for emitters in FIGs. 8A-8B can also be constructed for detectors. A detector D_k 's coverage area is then the aggregate of all footprints for beams received by a detector D_k . The aggregate of all detector coverage areas gives the overall system coverage.

E. Active Area Coverage

[0093] The coverage of the active area 131 depends on the shapes of the beam paths, but also depends on the arrangement of emitters and detectors. In most applications, the

active area is rectangular in shape, and the emitters and detectors are located along the four edges of the rectangle.

[0094] In a preferred approach, rather than having only emitters along certain edges and only detectors along the other edges, emitters and detectors are interleaved along the edges. FIG. 8C shows an example of this where emitters and detectors are alternated along all four edges. The shaded beams show the coverage area for emitter E_j .

F. Multiplexing

[0095] Since multiple emitters transmit multiple optical beams to multiple detectors, and since the behavior of individual beams is generally desired, a multiplexing/demultiplexing scheme is used. For example, each detector typically outputs a single electrical signal indicative of the intensity of the incident light, regardless of whether that light is from one optical beam produced by one emitter or from many optical beams produced by many emitters. However, the transmittance T_{jk} is a characteristic of an individual optical beam j_k .

[0096] Different types of multiplexing can be used. Depending upon the multiplexing scheme used, the transmission characteristics of beams, including their content and when they are transmitted, may vary. Consequently, the choice of multiplexing scheme may affect both the physical construction of the optical touch-sensitive device as well as its operation.

[0097] One approach is based on code division multiplexing. In this approach, the optical beams produced by each emitter are encoded using different codes. A detector receives an optical signal which is the combination of optical beams from different emitters, but the received beam can be separated into its components based on the codes. This is described in further detail in U.S. Application Serial No. 13/059,772 "Optical Control System With Modulated Emitters," which is incorporated by reference herein.

[0098] Another similar approach is frequency division multiplexing. In this approach, rather than modulated by different codes, the optical beams from different emitters are modulated by different frequencies. The frequencies are low enough that the different components in the detected optical beam can be recovered by electronic filtering or other electronic or software means.

[0099] Time division multiplexing can also be used. In this approach, different emitters transmit beams at different times. The optical beams and transmission coefficients T_{jk} are identified based on timing. If only time multiplexing is used, the controller must cycle through the emitters quickly enough to meet the required touch sampling rate.

[00100] Other multiplexing techniques commonly used with optical systems include wavelength division multiplexing, polarization multiplexing, spatial multiplexing and angle multiplexing. Electronic modulation schemes, such as PSK, QAM and OFDM, may also be possibly applied to distinguish different beams.

[00101] Several multiplexing techniques may be used together. For example, time division multiplexing and code division multiplexing could be combined. Rather than code division multiplexing 128 emitters or time division multiplexing 128 emitters, the emitters might be broken down into 8 groups of 16. The 8 groups are time division multiplexed so that only 16 emitters are operating at any one time, and those 16 emitters are code division multiplexed. This might be advantageous, for example, to minimize the number of emitters active at any given point in time to reduce the power requirements of the device.

III. Processing Phase

[00102] In the processing phase 220 of FIG. 2, the transmission coefficients T_{jk} are used to determine the locations of touch points. Different approaches and techniques can be used, including candidate touch points, line imaging, location interpolation, touch event templates, multi-pass processing and beam weighting.

A. Candidate Touch Points

[00103] One approach to determine the location of touch points is based on identifying beams that have been affected by a touch event (based on the transmission coefficients T_{jk}) and then identifying intersections of these interrupted beams as candidate touch points. The list of candidate touch points can be refined by considering other beams that are in proximity to the candidate touch points or by considering other candidate touch points. This approach is described in further detail in U.S. Patent Application No. 13/059,817, "Method and Apparatus for Detecting a Multitouch Event in an Optical Touch-Sensitive Device," which is incorporated herein by reference.

B. Line Imaging, Tomography

[00104] This technique is based on the concept that the set of beams received by a detector form a line image of the touch points, where the viewpoint is the detector's location. The detector functions as a one-dimensional camera that is looking at the collection of emitters. Due to reciprocity, the same is also true for emitters. The set of beams transmitted by an emitter form a line image of the touch points, where the viewpoint is the emitter's location. These line images can be processed to reconstruct the touch points, for example by using correlation or tomography principles. This approach is described in further detail in

U.S. Patent Application No. 13/460,703, "Detecting Multitouch Events in an Optical Touch-Sensitive Device using Touch Event Templates," and 14/092,850, "Optical Touch Tomography," which are incorporated herein by reference.

C. Location Interpolation

[00105] Applications typically will require a certain level of accuracy in locating touch points. One approach to increase accuracy is to increase the density of emitters, detectors and beam paths so that a small change in the location of the touch point will interrupt different beams. Another approach is to interpolate between beams. This approach is described in further detail in U.S. Patent Application No. 13/460,703, "Detecting Multitouch Events in an Optical Touch-Sensitive Device using Touch Event Templates," which is incorporated herein by reference.

D. Touch Event Templates

[00106] If the locations and shapes of the beam paths are known, which is typically the case for systems with fixed emitters, detectors and optics, it is possible to predict in advance the transmission coefficients for a given touch event. Templates can be generated a priori for expected touch events. The determination of touch events then becomes a template matching problem.

[00107] If a brute force approach is used, then one template can be generated for each possible touch event. However, this can result in a large number of templates. For example, assume that one class of touch events is modeled as oval contact areas and assume that the beams are pencil beams that are either fully blocked or fully unblocked. This class of touch events can be parameterized as a function of five dimensions: length of major axis, length of minor axis, orientation of major axis, x location within the active area and y location within the active area. A brute force exhaustive set of templates covering this class of touch events must span these five dimensions. In addition, the template itself may have a large number of elements.

[00108] Thus, in another approach, the set of templates is simplified. For example, one possible template for a touch event with a certain contact area is the set of all beam paths that would be affected by the touch. However, this is a large number of beam paths, so template matching will be more difficult. In addition, this template is very specific to contact area. If the contact area changes slightly in size, shape or position, the template for contact area will no longer match exactly. Also, if additional touches are present elsewhere in the active area, the template will not match the detected data well. Thus, although using all possible beam

paths can produce a fairly discriminating template, it can also be computationally intensive to implement. An alternative uses templates with less than all affected beams. For example, a simpler template may be based on only four beams that would be interrupted by a certain contact area. This is a less specific template since other contact areas of slightly different shape, size or location will still match this template. This is good in the sense that fewer templates will be required to cover the space of possible contact areas. This template is less precise than the full template based on all interrupted beams. However, it is also faster to match due to the smaller size. These types of templates often are sparse relative to the full set of possible transmission coefficients.

[00109] Note that a series of templates could be defined for a certain contact area, increasing in the number of beams contained in the template: a 2-beam template, a 4-beam template, etc. In one embodiment, the beams that are interrupted by contact area are ordered sequentially from 1 to N. An n-beam template can then be constructed by selecting the first n beams in the order. Generally speaking, beams that are spatially or angularly diverse tend to yield better templates. That is, a template with three beams running at 60 degrees to each other and not intersecting at a common point tends to produce a more robust template than one based on three largely parallel beams which are in close proximity to each other. In addition, more beams tends to increase the effective signal-to-noise ratio of the template matching, particularly if the beams are from different emitters and detectors.

[00110] Often, a base template can also be used to generate a family of similar templates. For example, contact area B may be the same as contact area A, but shifted to the right. The corresponding four-beam template for contact area B can then be generated from the template for contact area A, by making use of the right shift. More generally, the template for contact area A can be abstracted or parameterized (e.g., where the parameters are the amount of shift in different directions). The abstraction will be referred to as a template model. In one approach, the model is used to generate the individual templates and the actual data is matched against each of the individual templates. In another approach, the data is matched against the template model. The matching process then includes determining whether there is a match against the template model and, if so, which value of the parameters produces the match.

[00111] Templates can use both positive and negative regions. An actual contact area may be surrounded by a “touch-free” zone. If contact is made in the actual contact area, then there will be no contact in the immediately surrounding area. Thus, the template includes

both (a) beams in the contact area that are interrupted, and (b) beams in the shaded area that are not interrupted.

[00112] Templates can also be based both on reduced and enhanced transmission coefficients. For a particular type of contact, the transmission coefficients for certain beams that are interrupted should decrease. However, the touch interaction may scatter or reflect light in other directions, and the transmission coefficients for these directions should increase.

[00113] Other templates will be apparent and templates can be processed in a number of ways. In a straightforward approach, the disturbances for the beams in a template are simply summed or averaged. This can increase the overall SNR for such a measurement, because each beam adds additional signal while the noise from each beam is presumably independent. In another approach, the sum or other combination could be a weighted process, where not all beams in the template are given equal weight. For example, the beams which pass close to the center of the touch event being modeled could be weighted more heavily than those that are further away. Alternately, the angular diversity of beams in the template could also be expressed by weighting. Angular diverse beams are more heavily weighted than beams that are not as diverse.

[00114] Additional examples of touch event templates are described in further detail in U.S. Patent Application No. 13/460,703, "Detecting Multitouch Events in an Optical Touch-Sensitive Device using Touch Event Templates," which is incorporated herein by reference.

E. Multi-Pass Processing

[00115] Referring to FIG. 2, the processing phase need not be a single-pass process nor is it limited to a single technique. Multiple processing techniques may be combined or otherwise used together to determine the locations of touch events.

[00116] As one example, a first stage is a coarse pass that relies on a fast binary template matching. In this stage, the templates are binary and the transmittances T'_{jk} are also assumed to be binary. The binary transmittances T'_{jk} can be generated from the analog values T_{jk} by rounding or thresholding the analog values. The binary values T'_{jk} are matched against binary templates to produce a preliminary list of candidate touch points. Some clean-up is performed to refine this list. For example, it may be simple to eliminate redundant candidate touch points or to combine candidate touch points that are close or similar to each other. A second stage is used to eliminate false positives, using a more refined approach. For each candidate touch point, neighboring beams may be used to validate or eliminate the candidate as an actual touch point. The techniques described in U.S. Patent Application No.

13/059,817 may be used for this purpose. This stage may also use the analog values T_{jk} , in addition to accounting for the actual width of the optical beams. The output of stage is a list of confirmed touch points. The final stage refines the location of each touch point. For example, the interpolation techniques described previously can be used to determine the locations with better accuracy. Since the approximate location is already known, stage may work with a much smaller number of beams (i.e., those in the local vicinity) but might apply more intensive computations to that data. The end result is a determination of the touch locations.

[00117] Other techniques may also be used for multi-pass processing. For example, line images or touch event models may also be used. Alternatively, the same technique may be used more than once or in an iterative fashion. For example, low resolution templates may be used first to determine a set of candidate touch locations, and then higher resolution templates or touch event models may be used to more precisely determine the precise location and shape of the touch.

F. Beam Weighting

[00118] In processing the transmission coefficients, it is common to weight or to prioritize the transmission coefficients. Weighting effectively means that some beams are more important than others. Weightings may be determined during processing as needed, or they may be predetermined and retrieved from lookup tables or lists.

[00119] One factor for weighting beams is angular diversity. Usually, angularly diverse beams are given a higher weight than beams with comparatively less angular diversity. Given one beam, a second beam with small angular diversity (i.e., roughly parallel to the first beam) may be weighted lower because it provides relatively little additional information about the location of the touch event beyond what the first beam provides. Conversely, a second beam which has a high angular diversity relative to the first beam may be given a higher weight in determining where along the first beam the touch point occurs.

[00120] Another factor for weighting beams is position difference between the emitters and/or detectors of the beams (i.e., spatial diversity). Usually, greater spatial diversity is given a higher weight since it represents “more” information compared to what is already available.

[00121] Another possible factor for weighting beams is the density of beams. If there are many beams traversing a region of the active area, then each beam is just one of many and any individual beam is less important and may be weighted less. Conversely, if there are

few beams traversing a region of the active area, then each of those beams is more significant in the information that it carries and may be weighted more.

[00122] In another aspect, the nominal beam transmittance (i.e., the transmittance in the absence of a touch event) could be used to weight beams. Beams with higher nominal transmittance can be considered to be more “trustworthy” than those which have lower nominal transmittance since those are more vulnerable to noise. A signal-to-noise ratio, if available, can be used in a similar fashion to weight beams. Beams with higher signal-to-noise ratio may be considered to be more “trustworthy” and given higher weight.

[00123] The weightings, however determined, can be used in the calculation of a figure of merit (confidence) of a given template associated with a possible touch location. Beam transmittance / signal-to-noise ratio can also be used in the interpolation process, being gathered into a single measurement of confidence associated with the interpolated line derived from a given touch shadow in a line image. Those interpolated lines which are derived from a shadow composed of “trustworthy” beams can be given greater weight in the determination of the final touch point location than those which are derived from dubious beam data.

PART B: INSTRUMENT DETECTION

IV. Introduction

[00124] Detection of a pen, stylus or other instrument touch as distinct from a finger touch is an important attribute for many applications. In some applications, simple detection of an instrument touch event may be sufficient. Other applications may also require the ability to distinguish between different types of instruments.

[00125] Although separate mechanisms can be used to support instrument touch detection, it is preferable for an optical touch-sensitive device to be able to provide these features with little or no hardware modification. Instruments can broadly be categorized as either passive or active. Passive instruments interact with the optical beams transmitted between emitters and detectors but do not add energy. Active instruments may add energy and may contain their own emitter(s) and detector(s). Active instruments may be battery powered and typically will also contain another communications channel, for example a wireless connection, in order to coordinate their operation with the rest of the optical touch detection system. One advantage of instruments compared to fingers, is that the instrument, and specifically its tip, can be designed to achieve a specific touch interaction with the optical

beams. Different instruments can be designed to implement different touch interactions, and they can then be distinguished on that basis.

[00126] At least two classifications of data are available in an optical touch detection system for detecting instrument touches: beam data and cell data. Beam data relates to the attenuation experienced by the optical beams in the system. It should be noted that the attenuation for some beams under a touch can be negative (i.e., there is increased optical transmission) under certain circumstances, typically where there is reflection or scattering. Cell data relates to small areas (typically a few millimeters across) on the touch-sensitive surface where the attenuation values for beams passing through each of these areas is aggregated to give an indication of the localized activity in the area of the cell. The whole touch-sensitive surface is divided into cells.

[00127] In some cases, finger, palm and instrument contacts may all be present simultaneously on the touch-sensitive surface. In order to discriminate between instrument and other contacts, and between instrument identities (there may be more than one instrument associated with the system), each contact area can be analyzed.

V. Passive Instrument Detection

[00128] Instruments can be designed so that their touch interactions are uniquely identifiable. Some features are more reliable than others, some more rapidly detectable than others and some more easily implemented than others. In practice, more than one feature may be used to provide improved instrument detection and/or identification. Example features include: (A) contact area, (B) contact absorption rate over distance/area, (C) contact landing behavior over time, (D) pattern of absorption against beam angle, (E) pattern of reflection against beam angle, (F) ratio of reflection to attenuation, (G) wavelength-selective behavior, (H) refractive index of contact material, (I) birefringence of contact material, and/or (J) re-emission of received energy. These features can each be used to detect instrument touches and also to distinguish instrument touches from other types of touches (e.g., finger touches) and to distinguish between different types of instruments.

A. Contact Area

[00129] The contact area may be used to distinguish an instrument touch from another type of touch (e.g., a finger touch or touch by a different instrument). Because the instrument can be designed, there are more degrees of freedom to the contact area compared to a human finger. Contact area can be designed to differ in size and shape. Instruments, such as ordinary pens or styluses, typically have a tip that is smaller than a human finger and can be

distinguished on that basis. FIGs. 9A-9E are top views of different types of two-dimensional contact areas for instruments. FIG. 9A shows a contact area for an instrument with a small tip. The size alone may be used to distinguish this instrument from human fingers. FIG. 9B shows an asymmetric contact area, in this example an elongated ellipse. The different behaviors in the x and y directions can be used to identify this instrument, because human fingers typically have a more circular contact area and so are more isotropic in their touch interactions. FIGs. 9C-9E show contact areas that include multiple disjoint regions. In FIG. 9C, the contact area is a 2x2 array of contact regions. In this example, optical beams, such as beam 910, that hit the contact regions will be attenuated but optical beams, such as beam 920, that pass between the contact regions will not be affected. Movement of the instrument may enhance this effect, making it easier to detect. FIG. 9D is a one-dimensional version of the contact area of FIG. 9C. This also allows some determination of the orientation of the instrument. FIG. 9E is a version where the contact regions are not on a rectilinear grid. Because the instrument is manufactured, the individual features such as the individual contact regions can be made smaller and more precise than the features on a human finger.

B. Attenuation Rate

[00130] Although finger touches can give rise to a range of beam attenuation values, there is generally a maximum realizable attenuation rate per unit distance (the length of a beam which is underneath the contact) or per unit area that a finger can achieve. Instruments can be designed using materials and/or structures that have a significantly higher rate of attenuation. When detected, this can form a strong indication of a touch by a specially devised instrument tip.

[00131] The rate of attenuation for the size of the contact is determined based on an estimate of the contact size to be provided. Such an estimate is available from analysis of the beam data associated with the contact being assessed (for example, by counting the number of beams in the vicinity of the contact which are showing attenuation).

[00132] Once the size (and possibly also the shape) of the contact area is known, a geometric analysis can be used to estimate the path under the contact for each beam in the area. From this, the length of the path under the contact for each affected beam can be estimated and combined with the attenuation data for the beams to give an indication of the loss per unit distance travelled under the touch as an alternative to loss over the contact area. Both methods can give somewhat similar results.

[00133] Note that a measurement of attenuation rate for touch types other than instruments could also be useful, for example to detect when a finger may have a contaminant on it. This could be used to enable particular software or hardware mechanisms to optimize performance in the presence of contamination.

[00134] Regarding distinguishing between multiple instrument identities, mechanical or chemical modification of the instrument tip material can enable a range of attenuation rates to be achieved. The measured attenuation rate for an instrument touch could be used to determine the identity of the contacting instrument.

C. Touch Interaction over Time

[00135] Instruments can also be designed to have a different temporal behavior than fingers or other instruments. FIG. 10A shows a finger touch progressing in time. The finger touch at time t_1 initially shows a small contact area, perhaps consistent in size with an instrument tip, but the contact area typically increases in size rapidly as the finger “lands” on the waveguide, as shown at time t_2 and t_3 . This behavior over a very short period of time forms another distinguishing feature allowing finger touches to be recognized.

[00136] If an instrument is rigid, then it will make contact much more quickly as shown in FIG. 10B. At time t_1 , the instrument makes contact with the waveguide and it remains with the same contact area from then on. In FIG. 10C, the instrument is rigid and has some small amount of bouncing at time t_2 before settling to its final position at time t_3 . All of these behaviors are different than the finger touch shown in FIG. 10A. Discerning different touch types typically requires not more than a few milliseconds.

[00137] Temporal behavior can be captured based on the timing of the optical beams. For the sake of illustration, consider the configuration shown in FIG. 8C. Assume that there are a total of 28 emitters and 28 detectors. Further assume that the emitters are activated sequentially. Emitter E_a is activated, then emitter E_b , then emitter E_c , and so on until the final emitter E_J , and then the activation sequence repeats. Further assume that all 28 emitters can be activated in 10 ms (which will be referred to as the scan time or scan period), then 100 such scans could be performed in one second and one emitter is activated approximately every 360 μ s. In this example, the activation of optical beams will be determined by the activation of emitters. However, it could also be determined by the detector sampling or a combination of the two.

[00138] A new touch will generally disturb less than all, and typically only a few, of the optical beams from emitters to detectors. The set of disturbed optical beams and associated

emitter/detector pairs can be collected in a list. Since the timing of the activation of the emitters (and any corresponding timing for the detectors) is known, each optical beam can be ascribed a time at which it was active and disturbed.

[00139] Analyzing the data for these disturbed optical beams with reference to the timing of their activation allows the rate at which the contact landed to be estimated. For example, if the emitters in FIG. 8C were activated in numerical order one at a time and the detectors are all active simultaneously for each emitter activation, there would be 28 time steps in the 10 ms scan, each separated by about 360 μ s. This means that emitter Eb would be activated about 360 μ s after emitter Ea and so on. All of the associated detector data would be available in these 360 μ s increments.

[00140] Analyzing the disturbed optical beams, e.g. those passing through the contact area, over a given time period will give some indication of the rate at which the touch “landed” on the touch-sensitive surface. This analysis will be particularly effective if the optical beams used are selected such that they pass through a similar point in the contact (for example, the center). Many contacts are approximately disc-shaped, so the attenuation seen by each beam passing near the center of the disc over the time window in question is an approximate record of the peak attenuation caused by the landing contact in approximately 360 μ s intervals, which is 28 times faster than the full scan rate of 10 ms in this example.

[00141] FIG. 10D is a graph of the transmission coefficient T_{jk} of the optical beams passing under the center of a touch contact. The x-axis is time, as measured in 360 μ s increments by emitter activation. The data point for E_n plots T_{jk} for the optical beam from emitter E_n that passes under the center of the touch contact, the data point for E_{n+1} plots T_{jk} for the optical beam from emitter E_{n+1} that passes under the center of the touch contact, and so on. The data point for E_{n+1} occurs 360 μ s after that for E_n , due to the timing of the emitter activation. The optical beam does not necessarily have to pass through the exact center of the contact area to be useful, because an optical beam passing through any arbitrary section of a contact (of any shape) can be adjusted based on a model of the loss-per-unit-distance travelled under the contact. Note that the sequential activation of emitters results in a time sampling of the touch landing that is much finer than the full scan rate of 10 ms.

[00142] A finger touch will usually be a “slow” event compared to the landing of other materials such as pen tips. This can be seen from FIG. 10D. The transmission coefficient T_{jk} decreases more slowly for the finger touch than for the pen touch. This is because a

human finger has more flexibility than a pen tip, as also illustrated in FIG. 10A compared to FIG. 10B. The measured rate of beam attenuation can be correlated with object properties (e.g., rigidity) to make a determination of the type of material making contact with the waveguide. In this example, the optical touch-sensitive system would be able to distinguish between fingers and pens.

[00143] Other information about the landing of an object on the touch-sensitive surface may also be determined from the beam attenuation data. For example, if the attenuation is reduced momentarily after the landing event, this can be an indication that the touch has at least partially rebounded off the touch-sensitive surface (see FIG. 10C). The optical touch-sensitive system can interpret this reduction in attenuation as indicating that the contacting material is made of a resilient (e.g., “springy”) material.

[00144] These landing effects may also occur when the touch is moved or lifted. For example, further measuring of beam attenuations across multiple scans may be used to determine that the contacting object is moving to a different location on the waveguide or removed entirely. Any residual attenuation of the optical beams where the touch used to be located may, for example, be attributed to contamination residue left on the surface, such as oil from a human finger.

[00145] FIG. 10E is a graph of the transmission coefficient T_{jk} of the optical beams passing under the center of a touch contact before, during, and after a touch event. FIG. 10E shows a sudden partial recovery 1010 of the beam attenuation followed by a period 1020 of moderate, stable attenuation, but with more attenuation than before the touch. In this instance, despite the fact that the final attenuation value is greater than that present before the touch landed, the fast recovery and stable nature of the attenuation indicates that the touch has been removed or moved from this location on the touch surface. Generally, if some form of touch event were still present (e.g., a lightly / partially touching fingertip), the beam attenuation would not be as stable with respect to time. Here, the presence of a stable, constant attenuation indicates the deposition of a material, such as an oil.

D. Touch Interaction that Varies as a Function of Beam Direction

[00146] Finger touches are reasonably isotropic with respect to how much attenuation they introduce as a function of the direction of the interrupted beam. However, an intentionally structured instrument tip can show pronounced variations in attenuation as a function of the direction of the sensing beams. The instrument response will rotate with the instrument tip, so the detection mechanism should be capable of identifying the designated

response at any arbitrary orientation. Conversely, the detection process can yield information about the orientation of the instrument.

[00147] FIG. 11 is a diagram of nomenclature used to define an instrument response. An origin O and a 0 angle direction, denoted by the arrow, are defined with respect to the contact area 1110 of the instrument. For example, the origin O may be the center of the contact area, and the 0 angle may be chosen arbitrarily. An incoming optical beam 1120 is defined by coordinates (r, θ) , where r is the offset of the path of the incoming beam 1120 relative to the origin (i.e., the length of segment OP) and θ is the direction of propagation of the incoming beam. An outgoing optical beam 1130 is defined by coordinates $(\delta r, \delta \theta)$ relative to point P on the incoming beam 1120. The propagation direction for the outgoing optical beam 1130 is $\delta \theta$ relative to the incoming beam 1120, or $(\theta + \delta \theta)$ relative to the 0 angle. The outgoing beam 1130 is also offset by δr relative to point P of the incoming beam. The offset relative to the origin O is not necessarily $(r + \delta r)$, as can be seen from FIG. 11. On outgoing beam with $(\delta r=0, \delta \theta=0)$ is collinear with the incoming beam, outgoing beams with $(\delta r=0)$ all have paths through point P , and outgoing beams with $(\delta \theta=0)$ are all parallel to the incoming beam. The instrument's response can then be defined by the transmission function $H(r, \theta, \delta r, \delta \theta)$, which is the strength of an outgoing beam 1130 $(\delta r, \delta \theta)$ produced by an incoming beam 1120 (r, θ) . For convenience, the transmission function can be normalized so that $H = 1$ means that the outgoing beam 1130 has the same strength as the incoming beam 1120.

[00148] For “ideal” fingers, the contact area 1110 is circular, and the transmission function H exhibits some symmetries. For example, the transmission function H is independent of incoming beam direction θ . Also, due to symmetry, $H(r, \delta r, \delta \theta) = H(-r, -\delta r, -\delta \theta)$. Typically, the transmission function H is monotonically decreasing for increasing values of $|\delta r|$ and $|\delta \theta|$, i.e., for increasing offsets and increasing angular deviations of the outgoing beam. However, instruments can be designed specifically to violate any of these characteristics for ideal fingers. For example, consider the contact areas shown previously in FIGs. 9B-9E. None of these has a transmission function H that is independent of incoming beam direction θ .

[00149] The complicated contact area shapes in FIGs. 9B-9E can be implemented by creating an instrument tip where the individual contact regions couple light out of the waveguide of the touch-sensitive device (frustrated TIR) and the non-contact regions do not. For example, the contact regions may be constructed from a transparent material with an

index of refraction that matches the waveguide, so that light propagating in the waveguide passes into the material and then is absorbed or redirected elsewhere. The non-contact regions may be constructed of reflective materials to confine light to the underlying waveguide, or may be constructed with an air gap so that total internal reflection is not frustrated.

[00150] FIG. 12A is a front view of a more complicated tip structure. This tip structure includes a number of parallel waveguide channels 1210. FIG. 12B is a side cross-sectional view through the center of a waveguide channel 1210. Each waveguide channel 1210 is a strip of transparent material 1212 capped by an air gap 1214. The transparent material 1212 in this example has a matching refractive index to the waveguide of the touch-sensitive device. Materials of other indices of refraction can also be used. A higher index of refraction can shorten the travel distance of beams within the tip, thus allowing the tip to be made smaller. The rest of the tip is constructed from a material 1216. The material 1216 can be reflective or absorptive, which will produce different but distinctive instrument responses.

[00151] This tip offers selective reflection behavior that depends on the direction of the incident beam. FIG. 12C shows operation of a single waveguide channel 1210. Light ray 1220 is travelling along the +y direction, parallel to the waveguide channel 1210 which is also oriented along the y direction. As a result, light 1220 couples into the waveguide channel 1210. In FIG. 12C, the ray 1220 is shown as dashed when traveling in the underlying waveguide 1250 and solid when traveling in the waveguide channel 1210. The circle indicates the point of entry or exit from the waveguide channel 1210. The light 1220 experiences total internal reflection within the waveguide channel 1210 before coupling back to the underlying waveguide 1250.

[00152] Light rays that are propagating off-parallel relative to the orientation of the waveguide channel 1210 (e.g., at small angles relative to the y direction) will couple less efficiently. For example, a beam traveling along the x direction (perpendicular to the waveguide channel) may enter one or more of the waveguide channels, but will strike the side wall of the channel because the channels are not as wide as they are long. That ray will either be absorbed or reflected in large part by that side wall, depending on whether the side wall material is absorptive or reflective. This different behavior for rays propagating in the x and y directions yields a distinctive instrument response. This tip acts as a sort of directional filter, since the transmission function $H(r, \theta, \delta r, \delta \theta)$ is concentrated along certain preferred directions θ .

[00153] In addition to designing different patterns of attenuation, instruments can also be constructed to redirect incident light on paths other than those which would occur by propagation through the waveguide. An instrument tip of this type typically will include some reflective elements. As a result of such an instrument tip being in contact with the sensing waveguide, optical transmission will be reduced on some optical paths and increased on others. This is not a pattern that would normally occur with fingers, for example.

[00154] FIG. 13 is an example of an instrument tip that uses a prism 1310 to redirect light. In FIG. 13, the prism 1310 is represented by its base 1312 and two surfaces 1314 and 1316. The full prism is not drawn in FIG. 13 for clarity. In this example, the prism 1310 is constructed of a transparent material that is index matched to the underlying waveguide 1350 (although index matching is not required). Light ray 1320 is propagating along the +y direction in the waveguide and couples into the prism 1310 through its base 1312. The ray reflects off the two sides 1314, 1316, which are coated with reflective material. In some designs, the reflection may be the result of total internal reflection. The exiting light ray 1322 is redirected to the +x direction and at an angle that supports total internal reflection within the waveguide 1350. The re-routing of light can also be accomplished using other elements, such as retroreflectors, fibers, light pipes or waveguides. Gratings or other beamsplitting elements can be used to create multiple exit optical beams.

[00155] The transmission function H can be used in different ways to identify instrument touches and to distinguish different instruments. For example, many transmission functions are characterized by certain directions that exhibit strong attenuation or strong enhancement. That characteristic can be used to detect and identify instruments. The ratio of attenuated and enhanced beams can also be used. If there are multiple output beams, the number of beams with greater than a certain strength could be used.

[00156] As a further variation, the transmission function for an instrument may also depend on the orientation of the instrument. The instrument tip in FIG. 12 has a flat bottom, which is intended to be flush against the touch-sensitive surface. If the instrument is tilted, the bottom will not make the same contact and the transmission behavior will be different. Mathematically, the transmission function can be described as $H(r, \theta, \delta r, \delta \theta, \alpha, \beta)$ where α, β define the orientation of the instrument relative to the touch-sensitive surface. In some instruments, the transmission function is intended to be independent of the orientation α, β . Instruments with rounded tips help to facilitate this behavior because at least the physical contact will be the same – a rounded tip against a flat touch-sensitive surface – regardless of

the orientation of the instrument. Alternatively, the instrument can be intentionally designed to have a transmission function $H(r, \theta, \delta r, \delta \theta, \alpha, \beta)$ that varies as a function of the instrument orientation α, β .

[00157] Regarding distinguishing between multiple instruments, since many beams are affected by an instrument touch, this allow the transmission functions of different instruments to contain unique features to be identified. The processing workload associated with instrument identification will be strongly dependent on the number of different instruments to be identified. Also, other touches may occur simultaneously with one or more instrument touches, so reasonably complex transmission functions are preferred to provide robust identification.

E. Wavelength-Selective Touch Interaction

[00158] Wavelength can be used to add another dimension to touch interactions. This can allow touches to be assessed in a way which will readily distinguish an instrument tip which has spectral properties, such as narrowband absorption or reflection properties. Different wavelengths can be implemented at the emitter by using different emitter types or by selective use of optical filtering materials in the emitter couplers (to modify the limited spectrum generated by a single broadband LED type). Detectors are typically sensitive over a wide range of wavelengths, so energy from various emitter wavelengths can be detected. Note that the proportion of emitters operating at one wavelength relative to those operating at other wavelengths could be small or additional emitters provided specifically to aid with identification. An extension of this scheme would be to use emitters with visible wavelengths to detect the color of the contacting material. This kind of color detection could, for example, be used in drawing applications, where the color of the contacting material could be applied to the path traced by the contact. Alternately, broadband emitters could be used, with wavelength selectivity implemented at the detector. Detectors sensitive at different wavelengths could be used, or optical filters could be used with broader band detectors.

[00159] Regarding distinguishing between different instruments, in one implementation, one instrument might absorb (e.g., cause attenuation due to frustrated TIR) at a first wavelength but not at a second wavelength, while a different instrument absorbs at the second wavelength but not the first. Alternatively, instruments could be distinguished based on ratios of attenuation at different wavelengths. This could be extended to more than just two wavelengths.

[00160] FIG. 14 is a diagram of an instrument tip that attenuates over a narrow wavelength band. The tip includes transparent material 1410 with a matching index of refraction to the underlying waveguide 1450 (although index matching is not required). The tip also includes a narrowband spectral filter 1412, which passes wavelengths in a narrow passband centered at λ_0 . Light ray 1420 is at wavelength λ_0 , passes through the wavelength filter 1412, enters material 1410 and then is absorbed or otherwise prevented from reentering the waveguide 1450. Light ray 1422 is at a wavelength λ_0 that is outside the passband. This ray 1422 is reflected by the wavelength filter 1412 and remains in the waveguide 1450. In an alternate approach, the wavelength filter 1412 could block a wavelength band rather than transmitting a wavelength band.

[00161] FIG. 15 is a diagram of an instrument tip 1510 that uses a grating 1512. Light ray 1520 is at a shorter wavelength and light ray 1522 is at a longer wavelength. Both rays are diffracted into the first diffraction order. However, the angle of diffraction is greater for the light ray 1522 of longer wavelength. The diffracted ray 1520 still propagates at an incidence angle that is beyond the critical angle and remains confined within the waveguide 1550. However, the diffracted ray 1522 now propagates at an incidence angle that is less than the critical angle. Total internal reflection is lost and the optical beam 1522 is attenuated. The angle of diffraction and resulting wavelength behavior can be varied by changing the period of the grating and/or the efficiency of coupling into different diffraction orders.

F. Index of Refraction, Birefringence

[00162] Instruments can be constructed using materials with different indices of refraction, including birefringent materials. They can then be distinguished on this basis. The critical angle at an interface depends on the indices of refraction of the materials on both sides of the interface. Changing the index of refraction of the instrument tip changes the critical angle, which in turn affects whether an optical beam is transmitted into the instrument tip (i.e., removed from the waveguide) or total internally reflected back into the waveguide. If the optical beam includes a distribution of rays at different angles of incidence, then some may be transmitted and some reflected so that the aggregate attenuation of the instrument is between 0 and 1. Different angles of incidence can be provided by different coupler profiles. Synthetic materials can be produced with a very wide range of refractive indices.

[00163] FIG. 16 is a diagram of a tip 1610 with an index of refraction between air and that of the underlying waveguide 1650. The incoming beam 1620 includes rays propagating

across a distribution of propagation angles. For clarity, FIG. 16 shows only four angles, two of which are shown by solid lines and two by dashed lines. All of these rays are beyond the critical angle so they experience total internal reflection at sections of the waveguide 1650 which border air (i.e., where there is no touch). The instrument 1610 has a higher index of refraction so some of the steeper rays (dashed lines) couple into the instrument, which appears as attenuation at the detectors. Shallower rays (solid lines) are still beyond the critical angle for the interface with the instrument, so they are reflected at the interface and continue propagating within the waveguide 1650. By changing the index of refraction, the percentage of rays transmitted at the interface and the overall attenuation can be adjusted. Birefringent materials can be used to construct instruments with even more complex transmission functions, since the index of refraction varies as a function of polarization and angle of propagation.

G. Re-emission of Light

[00164] Photoluminescence is not present for finger touches but can be achieved by some synthetic materials. Fluorescence involves a spectral shift between the received and emitted energy. Phosphorescence does not necessarily have a spectral shift, but does introduce a time lag between reception and emission and may also include a change in propagation direction. Detection of the temporal “smearing” of the sensing energy would be readily detectable. Different chemistries can also provide widely different time constants.

VI. Active Instrument Detection

[00165] Actively powered instruments (active instruments) can provide additional capabilities. An active instrument may use solely optical input/output to operate in conjunction with the optical touch-sensitive device, or may have a wireless or other communications link with which to communicate data to the touch-sensitive device. The instrument tip may include optical emitter(s) for light injection into the underlying waveguide, optical detector(s) for light extraction from the waveguide, or both optical detector(s) and optical emitter(s). Instruments with emitter(s) will be referred to as injector instruments and those with detector(s) will be referred to as extractor instruments.

[00166] An active instrument can provide advantages, including possibly the following. (1) An active instrument can be designed to support different modes of operation. In addition, the mode might be selectable on the instrument itself (for example, the instrument color). (2) Adding active functionality increases the number of possible designs, thus allowing a larger number of possible instrument identities to be distinguished. (3) Additional

buttons and other user controls can be added to active instruments. (4) Force measurement and reporting can be added. (5) The instrument orientation, position, movement, etc. can be sensed and reported, for example by using accelerometers and gyroscopes. This can help improve the overall touch performance, especially when the instrument is moving fast. (6) Wireless connections can be implemented, which in turn can enable additional functions. For example, non-contact operations can be provided. Improved instrument tracking can be accomplished using supplementary data. Or advanced notice of imminent instrument activity can be provided.

[00167] Active instruments require a source of power. Batteries are one option, either replaceable batteries or rechargeable cells. Recharging might be done when the instrument is at rest in a holder.

A. Injector Instrument

[00168] FIGs. 17A-17B are a side view and top view of an injector instrument 1710. The injector instrument 1710 houses an optical emitter 1712 that injects (modulated) light 1720 into the waveguide 1750, and that light 1720 can be detected by the detectors of the touch-sensitive system. In FIG. 17B, the instrument 1710 produces only a single optical beam 1720. The light 1720 from the instrument can be designed so that it is distinguishable from the optical beams produced by the emitters on the periphery of the device, for example by using different time slots, wavelengths and/or modulation. The optical beam 1720 from the instrument can be used for different purposes.

[00169] For example, the optical beam 1720 can be used as a communications channel and not at all for touch detection, which may be accomplished using optical beams as described above. The communicated data can include any information about the instrument: its identity, operational mode or operational parameters, contact force, position, orientation or motion, for example. The data can be encoded using standard methods, such as modulating the optical beam 1720. A single beam 1720 is sufficient as long as the beam can be detected by any detector on the periphery. If the position of the instrument is known by other means, then which detector(s) receives the optical beam 1720 can be used to determine the orientation (rotation) of the instrument.

[00170] The optical beam 1720 can also be used for touch detection. In FIG. 17B, if the single optical beam 1720 has characteristics that vary as a function of distance, for example if it is a fan-shaped beam so that the fraction of the beam intercepted by a detector decreases

when the detector is farther away, then this can be used to assist in determining the touch location of the instrument.

[00171] In FIG. 17C, the instrument produces three fan-shaped beams 1720A-C. Distance from the instrument 1710 can be estimated based on the strength (or relative strengths) of the signals received by the detectors. This can then be used to triangulate the position of the instrument 1710. In FIG. 17D, the instrument produces four pencil beams 1720A-D, defining x and y directions relative to the instrument. The x-axis for the instrument can be estimated by a line connecting the detectors receiving optical beams 1720B and D, and the y-axis estimated by a line connecting the detectors receiving optical beams 1720A and C. The intersection of the x and y axes determines the touch location of the instrument 1710. These techniques can also be combined with the prior described techniques for determining touch events based on disturbing optical beams transmitted between emitters and detectors.

[00172] Regarding instrument identity, different instruments can be identified by having them emit different optical beams. Optical beams can use different wavelengths, time slots, frequency bands, encodings or modulations, etc. These can be used to distinguish different instruments.

B. Extractor Instrument

[00173] An instrument with a detector which detects optical beams from the underlying waveguide can implement various functions. First, the optical beam received can be used as a communications channel to transmit data from the rest of the touch-sensitive system to the instrument. In this case, the optical beam may or may not be one of the optical beams normally used for touch detection. In one approach, the optical beam is broadcast over a large area so that the instrument detector will receive the beam even if the position of the instrument is not known. In another approach, the position of the instrument is known and the optical beam is directed to that position.

[00174] An extractor instrument may also be used in touch detection. For example, the detector may be used to detect which optical beams from periphery emitters are received by the instrument. This information may be used to directly determine the position of the instrument, rather than or in addition to the prior described techniques for determining touch events based on disturbing optical beams transmitted between emitters and detectors.

C. Bidirectional Instruments

[00175] An instrument may contain both an emitter and a detector, in which case it is both an injector instrument and an extractor instrument. These instruments will be referred to as bidirectional instruments. There is more than one way in which such an instrument could interact with the touch-sensitive system. For example, it could simulate photoluminescence by emitting a delayed version of the signal received at the detector. Alternatively, the detector can be used to synchronize the emitter activity with that of the rest of the touch-sensitive system. The emitter and detector can also be used as a bidirectional communication channel for the transmission of data to/from the rest of the touch-sensitive system.

[00176] Regarding instrument identity, the coincident appearance of the instrument and the associated emitter modulation can provide information about the instrument identity. Also, the specific signal seen by the instrument detector can provide additional information regarding the approximate location of the instrument. Additional mode information from buttons and the like on the instrument can also be passed to the rest of the system.

D. Out of Band Communication Channel

[00177] Active instruments may have communication channels other than through the touch interaction, most likely wireless channels. The use of a wireless link provides ready support for many other features, such as mode selection and presentation control when not in contact with the touch-sensitive surface. Also, supplementary data from accelerometers, gyroscopes and other sensor types can be sent, which can be combined with the optically resolved tip location to provide improved sensing of the instrument motion. The supplementary data can also be sent over in-band channels (e.g., optical communication through the instrument tip). In contrast to approaches based on wireless links, this optical communication based approach can reduce cost and complexity, and can avoid pairing the active instrument with the sensors.

[00178] Since accelerometers and gyroscopes are often relative sensors which tend to drift over time, the combination with an absolute determination by the optical waveguide-based touch sensing is a powerful one. A particular attribute of an active instrument using accelerometers is that the rate of movement which can be handled is much increased. The accelerometer data can inform the optical waveguide sensor as to where the instrument tip is likely to be found in the next scan. This helps to compensate for motion blur.

[00179] Relating the specific movement of an instrument as reported from internal motion sensors to the movement seen on the optical waveguide sensor is a possible way of

confirming the instrument identity. The sensors could be internal to a specially constructed instrument or could be in a “collar” attached to a passive instrument. For example, an ordinary whiteboard marker will typically register well as a passive contact on an optical waveguide touch system. This can be useful in applications in which there is no graphical display associated with the touch-sensitive surface, but the path traced by an instrument on the surface is to be determined. However, attributes of the marker, such as the color of the ink, may not be easily detected by the waveguide-based system. Supplementary electronics attached to the marker could transmit to the touch-sensitive system data (for example, data relating to the motion of the instrument) which could be matched by the system with a corresponding path on the touch-sensitive surface. Once the sensed touch has been matched to the instrument, then attributes known by the system can be applied to the reports associated with that instrument. One example is the color of the marker. Another example is the size of the marker tip. Using motion information for identification and to supplement the quality of the reported motion could be applied to objects other than instruments, including fingers and objects which are to be used as physical controllers in contact with the touch-sensitive surface.

E. Power Management for Active Instruments

[00180] Regarding instrument charging, the body of a typical large instrument is reasonably well-suited to the use of popular cylindrical cells which may be non-rechargeable or externally rechargeable. However, it is likely to be preferable for the instruments to be rechargeable and for the charging to be supported by the touch-enabled device. An instrument holder could be provided with a facility to recharge the batteries, for example.

[00181] Regarding a low power mode, removal of an instrument from the holder could trigger the circuitry inside the instrument to be ready for presentation to the touch-sensitive surface. Otherwise, the instrument would be charging or in standby (low power) mode. Instruments with supplementary internal motion sensing (such as accelerometers) can use motion detection to control the internal circuit activity. When the instrument is motionless for a period of time, operation can be suspended. Occasional checking of the motion sensors can ensure that the instrument is fully operational when it comes into contact with the touch-sensitive surface.

[00182] When such an instrument is in motion and/or determined to be in proximity to the touch-sensitive surface, the touch-sensitive system can be placed into a mode which increases the time over which finger touches are analyzed before being reported. This is

beneficial to reduce the chances of a spurious finger report being generated as the side of the writing hand lands on the touch-sensitive surface. The side of a hand can generate a finger-sized contact before coming fully to rest on the touch-sensitive surface. In this mode, the sensor will be slightly slower to respond to finger touches, but that will often be acceptable.

F. Examples of Active Instruments

[00183] FIGs. 18A-18E are examples of different types of active instruments (e.g., injector instruments and bidirectional instruments). FIG. 18A is a basic injector instrument 1810 including a battery 1813, an emitter driver 1815, an emitter 1817, and a tip 1819. The emitter driver 1815 controls the emitter 1817. For example, the emitter driver 1815 generates control signals to activate the emitter 1817 to emit light and to de-activate the emitter 1817. The emitter 1817 in this basic injector produces a constant illumination when activated. Examples of the emitter 1817 include light-emitting diodes (LED) and continuous wave lasers. The tip 1819 has a hemispherical contact surface to contact the touch-sensitive device. This basic injector instrument 1810 may have a low cost, but an inefficient use of energy due to the constant illumination.

[00184] Compared with the injector instrument 1810, FIG. 18B is an injector instrument 1820 including an additional pulse generator 1823. The pulse generator 1823 generates pulses. For example, the pulse generator 1823 may generate pulses with pre-defined control parameters (e.g., repetition rate, delay, width or pulse duration, and amplitude, etc.) The pre-defined control parameters can be set by users who use the injection instrument 1820, or set by manufacturers. The emitter driver 1825 controls the emitter 1827 to emit light according to the generated pulses. Examples of the emitter 1827 may include a pulsed LED or a pulsed laser (e.g., a laser diode). The pulsed emitter 1827 reduces emitter duty cycle. Therefore, the injector instrument 1820 has more efficient use of energy. In some embodiments, the pulse generator 1823 modulates light emitted from the emitter 1827. Examples of modulation may include pulse amplitude (PAM), pulse position modulation (PPM), pulse width modulation (PWM), pulse code modulation (PCM), bi-phase coding, and frequency modulation (FM). For example, the pulse generator 1823 modulates the intensity of light emitted from the emitter 1827 such that data (e.g., a serial number, a user-selected code, a motion sensor information (not shown in FIG. 18B)) is encoded on the emitted light. In another example, the pulse generator 1823 modulates light intensity over time such that the injector instrument 1820 can be identified or distinguished from other active instruments.

[00185] Compared with the injector instrument 1820, FIG. 18C is an injector instrument 1830 including an additional pattern selector 1833 and a button or other user control 1835. The pattern selector 1833 is a user-selectable pulse encoding device that allows users to control the pulse generator 1823 and/or the emitter 1827. For example, the pattern selector 1833 allows users to push the button 1835 to change the control parameters of the pulse generator 1823. In another example, the pattern selector 1833 allows users to select an emission pattern encoded onto an output of the emitter 1827. The emission pattern can be projected by the emitter 1827 onto the touch-sensitive surface. Examples of emission patterns are further described below with respect to FIGs. 19A-19C.

[00186] Compared with the injector instrument 1820, FIG. 18D is an injector instrument 1840 including an additional motion sensor 1843. The motion sensor 1843 captures movement of the injector instrument 1840 over time. Examples of the motion sensor 1843 may include an accelerometer or a gyroscope. The captured movement can be used to control the emitter 1827. For example, if the motion sensor 1843 detects that the injector instrument 1840 is at rest, the emitter driver 1815 generates instructions to turn off the emitter 1827. If the motion sensor 1843 detects that the injector instrument 1840 is consistent with encountering the touch-sensitive surface, the emitter driver 1815 generates instructions to trigger the emitter 1827 to emit light.

[00187] Compared with the injector instrument 1820, FIG. 18E is a bidirectional instrument 1850 including an additional analyzer 1853 and an additional photodetector 1855. When the bidirectional instrument 1850 touches the touch-sensitive surface of the touch-sensitive device, the photodetector 1855 detects optical beams exiting the optical waveguide due to frustrated total internal reflection. Examples of photodetector 1855 may include avalanche photodiode (APD). The photodetector 1855 sends signals to the analyzer 1853 for further analysis. The analyzer 1853 analyzes the signals received from the photodetector 1855 and generates control signals to the emitter driver 1815. For example, if the photodetector 1855 does not detect exiting optical beams, this might indicate that the instrument 1850 is not in contact with the optical waveguide and the analyzer 1853 generates signals to turn off the emitter 1827. In another example, the analyzer 1853 derives a timing reference to ensure that the emitter 1827 emits during time periods to reduce possible interference with other optical beams. As such, power consumption of the emitter 1827 and a latency of receiving emissions from the emitter 1827 by optical detectors included in the touch-sensitive device may be reduced.

[00188] In some embodiments, the photodetector allows the active instrument to receive data from the touch-sensitive device (e.g., an extractor instrument or a bidirectional instrument). For example, the photodetector 1855 receives data and/or commands encoded by the emitters included in the touch-sensitive device and these data and/or commands are processed by the analyzer 1853. The data and/or commands may be transmitted from the touch-sensitive device to the active instrument during a time period to reduce interference with optical beams used to detect touch events.

[00189] In some embodiments, not shown in FIG. 18E, the photodetector assists in transmitting motion data from the active instrument to the touch-sensitive device. For example, if the active instrument loses contact with the optical waveguide surface (intentionally or otherwise), the photodetector 1855 will not detect exiting optical beams and the emitter 1857 will not be able to transmit data to the touch-sensitive device. The analyzer 1853 then buffers motion data collected by motion sensors on the active instrument until contact is reestablished. The motion data from the active instrument provides motion information of the active instrument during the time period of contact loss when the touch-sensitive device cannot track movement of the active instrument. This bridges breaks in the active instrument's movement and can also be used to determine when the user intentionally lifts the active instrument off the surface (e.g., with significant acceleration away from the surface). If the time period of contact loss exceeds a threshold indicating that the contact loss is prolonged, queuing ceases and the queued motion data is discarded.

[00190] FIGs. 18A-18E are just examples. Other variations may modulate the emitted light in different ways, either externally or internally. Examples of modulation include changes in intensity, phase, coding, polarization, wavelength, and spatial emission pattern.

[00191] An active instrument injects light into the optical waveguide according to an emission pattern. The emission pattern describes the distribution of light injected by the active instrument and can be characterized by several parameters, such as optical beam intensity, spatial and angular distribution of light, wavelength, and changes of the above parameters over time. By adjusting one or more parameters, different active instruments may have their own specific emission patterns. As such, an active instrument can be identified based on the injected light detected by the touch-sensitive device in comparison to the instrument's emission pattern. The emission patterns can be predetermined or controlled by the user. For example, the user pushes the button to select and/or change the emission pattern. Examples are further described below with respect to FIGs. 19A-19C.

[00192] FIG. 19A shows an emission pattern, in which the spatial distribution of light injected by an active instrument varies over time. The dot 1900 is the point where the active instrument makes contact with the optical waveguide. At time t1, the active instrument injects light according to an emission pattern 1903A. The emission pattern 1903A has an angular distribution with an elliptical shape. For illustration, the arrows show three optical beams. The length of each arrow indicates a respective intensity (or strength) of that optical beam. At time t2, the intensities of the relative intensities of the optical beams are different, resulting in an egg shape emission pattern 1903B. At time t3, changed optical beams result in yet a different emission pattern 1903C, which has a two-lobed shape in angular distribution. The spatial variation of shapes 1903A-C over time can be used to distinguish this active instrument from other active instruments. Additionally and/or alternatively, all emission directions can be modulated at the same time.

[00193] In some embodiments, the emission pattern describes a spatial variation of injected light as a function of angle. For example, the emission pattern can be defined based on a polar coordinate system or a spherical coordinate system. Accordingly, the emission pattern can be light intensity as a function of circular polar angle relative to a reference point (e.g., a contact center of the active instrument), or the emission pattern can be light intensity as a function of spherical polar angle relative to a reference normal (e.g., a center normal of the contact surface). Different instruments can have emission patterns with different spatial intensity distributions. Therefore, active instruments can be identified and distinguished based on their specific emission patterns.

[00194] In some embodiments, the emission pattern includes intensity modulation of the injected light over time. The intensity of the emission pattern may be modulated via PAM, PPM, PWM, PCM, bi-phase coding, or FM. For example, in FIG. 19A, assume that the spatial distribution 1903A is assigned to each of two active instruments. However, the emission pattern of each instrument is also frequency modulated at a different frequency. Thus, the two active instruments can be identified and distinguished from other instruments based on the spatial distribution, and from each other based on the different frequency.

[00195] In some embodiments, the emission pattern includes wavelength variation of the injected light over time. For example, two active instruments may emit at different wavelengths, or may cycle through different wavelengths over time using a different sequence of wavelengths.

[00196] The emission pattern can be generated through the use of optical component(s) located between the emitter of the active instrument and the touch-sensitive surface. In one design, the optical component controls light intensity distribution that is projected on the touch-sensitive surface. Examples of the optical component include spatial light modulators, aperture wheels, optical filters, and optical blockers. A pattern selector (e.g., the pattern selector 1833) may select an emission pattern to be projected on the touch-sensitive surface based on an input from the user via a button, or based on a predefined setting.

[00197] FIGs. 19B-19C illustrate implementation of an emission pattern in an active instrument. An emitter 1910 may emit continuous wave light or pulsed light into an optical waveguide 1930. A beam expander 1920 collimates the emitted light and expands its size to cover an aperture wheel 1925. The aperture wheel 1925 has a pattern of a first area 1925A that transmits light (e.g., a light beam 1927) and a second area 1925B that absorbs or blocks light (e.g., a light beam 1923). The expanded light passes the aperture wheel 1925 to generate an emission pattern such that light propagates in directions constrained by the pattern of the aperture wheel 1925.

[00198] In some embodiments, special emission patterns can be used to enable special functions, such that the device's functions that are not available to other users may be activated upon detection of the special emission pattern.

[00199] In some embodiments, the emission pattern can be used to determine an approximate location of the active instrument. Examples of such emission pattern are described above with respect to FIGs. 17C and 17D.

G. Associating Touch Events with Active Instruments

[00200] As described above, the locations of detected touch events are determined based on disturbances of the optical beams as a result of frustrated total internal reflection coupling energy out of the optical waveguide at the detected touch events, using one or more approaches, such as candidate touch points, line imaging, location interpolation, touch event templates, multi-pass processing and beam weighting. Also as described above, different active instruments can be identified and distinguished. As described further below, detected touch events can be linked with active instruments such that information specific to the detected touch events can be combined with respective identified active instruments (or vice versa) for various applications, e.g., assisting in distinguishing different active instruments with the same emission pattern, or assisting in data transmission from the active instrument to the touch-sensitive device (or vice versa). This is particularly useful when there are multiple

instruments present. For example, it would be beneficial if multiple people could draw at the same time on the same touch-sensitive surface. In that case, there will be multiple instruments and multiple detected touch events. It is important to make the correct associations between the active instruments and the detected touch events.

[00201] FIG. 20 is a flow diagram for making an association between an active instrument and a detected touch event. The process 2000 in FIG. 20 may be performed by the touch-sensitive device 100. The process 2000 may include different or additional steps than those described with respect to FIG. 20 in some embodiments or perform steps in different orders than the order described with respect to FIG. 20.

[00202] The touch-sensitive device 100 receives 2010 information specific to each of one or more detected touch events. Examples of this type of information may include a contact location, a contact size, a movement (e.g., motion data of direction, speed, distance, trajectory, etc.) of the detected touch event, information associated with the disturbed optical beams (e.g., transmittance of the optical beams disturbed by the detected touch event, transmission coefficients, detector data, etc.), and time variations of the above information.

[00203] The touch-sensitive device 100 receives 2020 information specific to an active instrument. Examples of this type of information may include an approximate contact location, a strength of optical coupling between the active instrument and the optical waveguide, a movement (e.g., motion data of direction, speed, distance, trajectory, etc.) of the active instrument, an emission pattern, a pattern of the injected light detected by the touch-sensitive device 100, and time variations of the above information.

[00204] The touch-sensitive device 100 analyzes 2030 the information specific to the active instrument and the information specific to the detected touch events for consistency with a situation in which the active instrument caused one of the detected touch events. A consistency describes a relationship between the information specific to the active instrument and the information specific to one of the detected touch events. Examples are further described below with respect to FIGs. 21-23.

[00205] The touch-sensitive device 100 makes 2040 an association between the active instrument and one of the detected touch events based on the analysis. For example, assume there are five detected touch events #1-5. It may be that the analysis determines that the optical coupling experienced by the active instrument is consistent with the optical coupling that occurs at touch event #2. Based on this, an association is made between the active instrument and detected touch event #2. The associations can be based on different types of

information, such as optical coupling, movement, time variations, and emission patterns. These are discussed in further detail below.

[00206] Optical Coupling. Making an association between the active instrument and one of the detected touch events can be made based in part on a consistency between the transmittance of the optical beams disturbed by the detected touch event and the strength of optical coupling between the active instrument and the optical waveguide.

[00207] As described previously, emitters and detectors are arranged around a periphery of a touch-sensitive surface, and optical beams propagate from the emitters to the detectors by total internal reflection in the optical waveguide. The optical beams are disturbed by one or more touch events via frustrated total internal reflection. The transmittance of the optical beams disturbed by each of the detected touch events between the emitter(s) and the detector(s) can be determined.

[00208] In the meantime, if an active instrument such as shown in FIG. 18 touches the optical waveguide, there will be optical coupling between the active instrument and the optical waveguide. If the active instrument injects light into the optical waveguide, then the strength of this optical coupling can be measured based on how much light is coupled into the waveguide. If the active instrument has a photodetector, the strength of the optical coupling can be measured based on how much light is coupled out of the optical waveguide by frustrated total internal reflection and into the active instrument. Accordingly, the strength of optical coupling between the active instrument and the optical waveguide can be determined based on the light injected from the active instrument and coupled into the optical waveguide and/or based on the optical beams coupled out of the optical waveguide. If the optical coupling observed by the active instrument is consistent with that observed for one of the detected touch events, then an association can be made between the active instrument and that detected touch event.

[00209] In some embodiments, the comparison can be made over time. FIGs. 21A-21C illustrate associating an active instrument with a detected touch event based on transmittance of optical beams. In FIG. 21A, the active instrument 2101 does not contact the optical waveguide 2105. As a result, the optical beam 2107A emitted by emitter IE of the active instrument 2101 does not meet the conditions of total internal reflection in the optical waveguide 2105 and does not couple into the optical waveguide. Most of the energy detected by detector(s) D is from optical beams emitted by emitter(s) E and very little, or none, is from the injector emitter IE. Accordingly, as shown in the time plot of FIG. 21C, in the time

period before time t1 (which is when the active instrument 2101 starts to make contact with the optical waveguide 2105), the transmittance curve 2113 of optical transmission between E and D is relatively strong because there is little loss to the active instrument, and the transmittance curve 2115 of optical transmission between IE and D is relatively weak because there is little to no coupling between the active instrument 2101 and the optical waveguide 2105.

[00210] In FIG. 21B, the active instrument 2101 has fully landed on the optical waveguide 2105. Optical beam 2107B from the active instrument 2101 is coupled into the optical waveguide 2105 and arrive at the detectors D. Optical beams 2102 from the emitters E are more strongly coupled out of the optical waveguide 2105 and pass into the active instrument 2101. Accordingly, as shown in FIG. 21C, after time t1, the transmittance 2113 from E-D decreases, while the transmittance 2115 from IE-D increases. At time t2 (which is when the active instrument 2101 fully lands on the optical waveguide 2105), the transmittance curve 2113 has a minimum transmittance value due to the coupled-out light, while the transmittance curve 2115 has a maximum transmittance value due to the coupled-in light. In addition, the two curves are consistent in their time variation. One increased when the other decreases. Therefore, an association can be made between the active instrument 2101 and the detected touch event shown.

[00211] Movement. Making an association between the active instrument and one of the detected touch events can be made based in part on a consistency between the movement of the detected touch event and the movement of the active instrument. The movement of the detected touch events can be tracked by tracking their changing locations over time. The movement of the active instrument can be tracked, for example, by a motion sensor in the active instrument. If a detected touch event's movement is consistent with the movement captured by the motion sensor, the detected touch event can be associated with the active instrument.

[00212] FIGs. 22A-22C illustrate associating an active instrument with a detected touch event based on movement of the active instrument and detected touch event. As shown in FIG. 22A, a touch-sensitive surface 2200 has emitters and detectors (not shown) arranged around its periphery. Optical beams between these emitters and detectors are used to detect and track movements of two touch events 2210 and 2220. The two touch events have an initial landing point L1 and L2 (where L1 and L2 occur at the same time) and then follow trajectories 2215 and 2225, respectively. The trajectory curves 2215 and 2225 are sampled at

the landing time and at four additional time points marked by the black dots. Time intervals between the time points may be equally spaced. As shown in FIGs. 22B and 22C, at the same time points, an active instrument 2230 has a motion sensor 2237 that captures a trajectory curve 2235, and an active instrument 2240 has a motion sensor 2247 that captures a trajectory curve 2245. The hollow circles are the time points corresponding to the landing points L1 and L2. Note that these trajectories may be relative trajectories without reference to absolute position or orientation. By comparing the trajectory curves 2235, 2245 of the active instruments with those 2215, 2225 of the touch events, the active instrument 2230 is associated with the touch event 2210 and the active instrument 2240 is associated with the touch event 2220.

[00213] Simpler time associations can also be made. For example, the two touch events 2210, 2220 could land at different times. Landing L1 occurs at time t_1 , and landing L2 occurs at a different time t_2 . If the active instruments also can determine their landing times as t_1 and t_2 , this can be used to associate the correct active instrument to each detected touch event.

[00214] In some embodiments, the consistency (or lack of consistency) between movements of the active instrument and the detected touch event assists in data transmission from the active instrument to the touch-sensitive device (or vice versa). When the touch events move quickly and lightly, or when there is a contamination on the surface of the device, a momentary loss of contact between the instrument and the touch-sensitive surface can occur. An inconsistency between the movements of the detected touch event and the active instrument can indicate such a loss of contact. In that case, the instrument may stop transmitting data (such as motion data) and instead buffer the data for transmission after contact is reestablished. The emitter may also be turned off. When contact is reestablished, the instrument turns on the emitter and transmits the buffered data. During the period when there is no contact, the touch-sensitive device will have a gap in position data. Motion data collected by the instrument during this time period may be used to bridge this gap.

[00215] Emission Pattern. Making an association between the active instrument and one of the detected touch events can be made based in part on a consistency between the pattern of injected light that is actually detected and the patterns that would be produced by the emission pattern of the active instrument centered at the location of the detected touch event.

[00216] FIGs. 23A-23D illustrate associating an active instrument with a detected touch event based on emission pattern of the active instrument. As shown in FIG. 23A, the touch

event 2210 at the location L1 emits optical beams in a first emission pattern 2310 that has four primary detections. This emitted light is detected by detectors D1, D7, D20 and D28. At the location L2, the touch event 2220 emits optical beams in a second emission pattern 2320. That light is detected by detectors D8, D21 and D36. As shown in FIG. 23B, one of the active instruments injects light into the touch-sensitive device 2200 according to an emission pattern 2340 that has three primary directions represented by the three arrows. To associate one of the touch events 2210, 2220 with the active instrument, a set of possible detection patterns that would be produced by the emission pattern 2340 centered at the locations L1, L2 of the detected touch events is computed. For example, a template including the patterns that would be produced by the emission pattern 2340 centered at different locations is computed. At each location, the template may include all possible variations of the emission pattern 2340, such as rotation of the emission pattern in this example.

[00217] As shown in FIGs. 23C and 23D, two patterns 2350 and 2360 are computed at location L1 based on the emission pattern 2340. The pattern 2350 would be detected by D5, D21 and D29, and the pattern 2360 would be detected by D2, D9 and D25. The computed patterns 2350 and 2360 are compared with the patterns that are actually detected by the detectors. These computed patterns 2350 and 2360 are not consistent with the actual detected patterns. This process is performed for all patterns from the active instruments and all locations of the detected touch events (locations L1 and L2 in this example). The process can be implemented by using templates based on the different emission patterns. As a result of this comparison, a version of emission pattern 2340 located at L2 is found to be consistent with the observed pattern of light detected by the detectors. Therefore, the active instrument with emission pattern 2340 is associated with the detected touch event at location L2.

[00218] Alternatively, an approximate location for the active instrument can be estimated based on the emission pattern for the active instrument and the actual pattern of injected light detected by the detectors. For example, the emission pattern 2340 may be overlaid on the actual pattern of detected light in FIG. 23A to estimate possible locations for the active instrument. If these locations overlap with known locations L1 or L2, then this consistency between the estimated approximate location for the active instrument and the known locations of the detected touch events can be used to make an association between the active instrument and the detected touch event.

[00219] In some embodiments, the touch events 2210 and 2220 move over time or the emission pattern changes over time (as shown in FIG. 19A). This time variation may also be

used to associate active instruments with touch events. Locations of each detected touch event over time can be determined by the device 2200. At each time point and each location, a collection of patterns that would be produced by the emission pattern 2340 centered at the location of the detected touch events is computed. By comparing the pattern actually detected by detectors with the computed patterns at each time point, the active instrument can be associated with one of the detected touch events.

[00220] In some embodiments where the emission pattern varies as a function of orientation of the instrument, the orientation of the active instrument is also determined based on comparison of the observed pattern of light detected by the detectors with patterns that would be generated for different orientations of the instrument. For example, assume that the active instrument has a hemispherical tip and, when the instrument is vertical, it produces an emission pattern with three equal strength lobes separated by 120 degrees. If the instrument is rotated while remaining vertical, the three lobes will be detected by different sets of detectors, thus providing orientation information about the instrument. In addition, if the instrument is tilted away from vertical, the three lobes will become uneven in strength. The detected pattern will thus give information about the tilt angle of the instrument. In one approach, a set of patterns is computed to cover different rotations and tilts. These templates are compared against the actual pattern captured by the detectors to determine orientation of the instrument.

[00221] Emission patterns can also be used to help determine whether an active instrument is in good contact with the touch-sensitive surface. If the contact is degraded, for example due to light contact or contamination on the surface, the emission pattern may also be degraded. Thus, a “noisy” detected emission pattern may be an indicator of less than full contact, while a well-defined emission pattern may be an indicator of good contact.

[00222] FIG. 24 illustrates distinguishing two active instruments that have the same emission pattern. A first active instrument producing an emission pattern 2430 is associated the touch event 2410, and a second active instrument producing the same emission pattern 2440 is associated the touch event 2420, based on different locations or based on movements as described above. Even if the detected patterns are the same, the two active instrument can be distinguished based on different contact locations.

[00223] The techniques described above to associate or identify active instruments based on different types of information (such as optical coupling, movement, time variations, and emission patterns) are not limited to total-internal-reflection based optical waveguides. They

can also be used with other mechanisms, such as touch sensing based on propagation of optical beams “above the surface” rather than frustrated total internal reflection in optical waveguides.

H. Coupling Light from Active Instruments into Optical Waveguide

[00224] As described above, if an active instrument does not contact an optical waveguide, light emitted by the active instrument typically will not meet conditions of total internal reflection in the optical waveguide. As a result, coupling of emitted light from the active instrument into the optical waveguide will be weak. However, there are cases where coupling without contact can be beneficial. For example, this can establish a communication channel when the active instrument is close to the waveguide but without actual contact.

[00225] Adequate optical coupling without contact can be achieved by having one or more areas on the waveguide surface designed to direct externally originated light into the waveguide at an angle supported by total internal reflection so that it propagates to the detectors. This can be achieved using a total internal reflection (TIR) coupler to redirect the injected light into the optical waveguide at an angle supported by TIR.

[00226] A TIR coupler redirect incident light into an optical waveguide at an angle supported by TIR such that light propagates to detectors via TIR. Examples of the TIR coupler may include a prism, an optical grating, a scattering element, or an optical element having a surface that is not parallel to the surface of the optical waveguide. The TIR coupler may be placed on the top surface of the waveguide. If light is emitted by an active instrument, the emitted light passes into the TIR coupler and exits at an angle that meets conditions of TIR of the optical waveguide. As such, even if the active instrument does not contact the waveguide, light emitted from the active instrument can propagate to detectors via TIR.

[00227] Coupling light into an optical waveguide without bringing an active instrument into contact with the surface can be used for various applications. For example, communication between the active instrument and the touch-sensitive device can be performed. In another example, applications and/or functions of the device (or the active instrument, e.g., pen drawing width) can be selected by users via the active instrument. Additionally, an approximate location of the active instrument can be estimated (e.g., by determining detector(s) over which the emissions are most intense). For example, the approximate location of the active instrument can be used to select applications or functions from a menu of colors or line widths displayed on the device (e.g., border area). Final

selection can be made by pressing or releasing a button on the active instrument or by moving the active instrument away from the location where the menu is so that the coupled light from the active instrument diminishes.

[00228] Alternatively, light from an active instrument may be injected into the optical waveguide only when the active instrument contacts the surface of the optical waveguide. This can be achieved by an active instrument with a TIR layer. FIGs. 25A-25B are examples of coupling injected light from an active instrument 2510 into an optical waveguide 2520 using a TIR layer. As shown in FIG. 25A, the active instrument 2510 has a TIR layer 2515 in which an optical beam 2513A emitted from an emitter (e) propagates to a detector (d) via TIR. The optical beam 2513A does not propagate outside the active instrument 2510. The touch-sensitive device has an optical waveguide 2520 and an optical beam 2523A propagates between an emitter (E) and a detector (D). As shown in FIG. 25B, when the active instrument 2510 contacts the optical waveguide 2520, the optical beam 2513B of the active instrument 2510 is injected into the waveguide 2520 and travels to the detector (D). Meanwhile, the optical beam 2523B of the waveguide 2520 is coupled into the active instrument 2510 and propagates to the detector (e). In an alternative embodiment (not shown in FIGs. 25A-25B), the TIR based active instrument 2510 does not have the detector (d). The TIR based active instrument can be used in other touch-sensitive devices that do not use the optical waveguide.

VII. Additional Modalities

A. Palm Management

[00229] When instruments are used with touch-sensitive surfaces more than a few inches in dimension, the user is likely to rest the side of the writing hand on the touch-sensitive surface. These are commonly known as “palm” touches even though they are most often associated with the side of the hand rather than the palm.

[00230] An optical waveguide touch-sensitive system can accommodate palm touches since not all of the light passing under the palm is likely to be absorbed and the pattern of optical beams can be arranged so that there is a high likelihood of some passing under the instrument tip, but not under the palm. For example, with optical emitters and detectors around the periphery of the touch-sensitive surface, there will usually be optical beams travelling between top and bottom (or front and back) of the surface which pass through the instrument contact area without touching the palm contact area, which will usually be to the right or left of the instrument tip.

[00231] The first step in managing palm touches is to detect them. One way to detect a palm touch as distinct from an instrument touch is to divide the touch-sensitive surface into regions which can be referred to as “cells.” In one embodiment, possible instrument touches are qualified, including eliminating palm touches, using cells according to the method shown in FIG. 26.

[00232] Divide 2610 the touch-sensitive surface into regions (cells) which are smaller than a palm’s contact area and larger than an instrument’s contact area. Determine 2612 which beams pass through each cell. Calculate 2614 the proportion of beams in the cell which have been disturbed by a touch. If the proportion is large 2620, then reject the cell as a possible instrument touch. If the proportion is small (e.g., below a threshold percentage) 2620, it may be an instrument touch but it may also be part of a larger palm touch. Consider these cells to be candidate instrument cells. For the candidate instrument cells, check 2622 the neighboring cells. Candidate instrument cells which have neighboring cells that show beam activity consistent with a palm touch are rejected as instrument touches, on the basis that the candidate instrument cell is probably a cell at the edge of a palm touch. In the remaining candidate instrument cells, calculate 2625 the range of angles of active beams. If the angular range is small 2630, the beam activity in the cell may be an artifact of touches elsewhere and the cell is rejected as an instrument touch. Otherwise 2630, the cell remains 2632 a viable candidate for an instrument touch. Other techniques can be applied to further determine whether there is an instrument touch.

[00233] Once palm activity has been identified, some applications may reject it by doing nothing more with the palm information. Other applications may determine attributes of each palm touch, such as the location, shape and size. Information about a palm touch can be used to provide enhanced performance. When an instrument is being used and the side of the writing hand is detected on the touch-sensitive surface, all further touches between the palm and the instrument tip can be ignored. For example, finger-like touches on the instrument side of a palm are likely to be associated with inadvertent finger/knuckle touches with the touch-sensitive surface. Some knowledge of the location and extent of the palm touch is helpful in determining the region in which inadvertent touches are to be ignored. A simple approach would be to ignore finger-like touches in a region of fixed size around the instrument tip.

B. Acoustics

[00234] Mechanical vibrations at the surface of a touch-sensitive device can be useful to determine the nature of a material that touches the surface. For example, a hard material landing on the surface will typically generate a sharp acoustic transient. Augmenting information from a waveguide touch-sensitive device with acoustic input from a contact microphone or other transducer associated with the touch-sensitive surface can provide additional capabilities to identify materials.

[00235] When the touch-sensitive device detects a new touch at a time which is coincident (within margins which allow for the respective latency of the two sensing methods) with the acoustic report, the acoustic signal can be associated with that touch. Further confidence in that association can be gained by analysis of the acoustic signal generated by movement of that touch and its consistency with the activity detected by the touch sensor.

[00236] An example of the application of such a system is the detection of instrument touches as distinct from finger touches on a touch-sensitive surface. If the instrument tip is composed of material which is not similar to a finger, then the characteristics of the vibration pattern generated on landing will be different. The tip material is important, but also the composition of the instrument itself. An instrument with a large mass will generate a different landing transient than one which is lightweight. Appendages may be introduced into the design of an instrument specifically to provide a distinctive acoustic signature. For example, a loose mass in the hollow body of an instrument can give rise to a second transient after the one generated by the landing of the tip.

[00237] The acoustic signal can also be used to reduce the power consumption of a touch-sensitive system. Scanning of the system may be disabled until an acoustic signal is detected, which may indicate the arrival of a new touch on the touch-sensitive surface.

[00238] Also, vibrations are typically present when a touch is lifted from the surface. This information can be particularly useful in overcoming the “stuck” touch problem in optical waveguide systems, where a patch of a contaminant left by a touch which has been lifted is sufficient for the system to falsely report that the touch is still present. The acoustic signal associated with the touch being lifted provides a helpful clue that it has in fact been removed and that only contamination remains on the surface at that location.

[00239] Acoustic detection can robustly reject vibrations caused by unrelated vibration activity. This can be achieved firstly by relying on high-frequency components in the

acoustic signal. These are usually absorbed rapidly when passing through the body of a device. For example, an acoustic sensor in a computer display monitor on a desk will not usually receive much high frequency vibration energy from the desk because the desk material, the monitor housing and the soft padding on the underside of the monitor base will absorb it. So, the high frequency energy (which is also the energy that results in fast-moving acoustic transients) will usually result only from vibrations introduced at the surface of the monitor itself. Also, more than one acoustic sensor can be used and analysis of the signals from multiple sensors can determine whether the vibration originated at a point which is outside of the touch-sensitive area. For example, where there are contact microphones at the left and right edges of the touch-sensitive area, a transient generated by a landing event on the touch-sensitive area should arrive at the two sensors with a time difference which is smaller than the time-of-flight of the vibration across the area. If the time of arrival for the signal at the two sensors is different by the full span of the surface between them, then it can be concluded that it originated at a point which is outside of the touch-sensitive surface.

[00240] An extension of this time-of-flight analysis of the acoustic signal can determine an approximate location to be compared with that reported by the optical waveguide touch sensing so that the association between them can be more reliable.

[00241] Analysis of the signal can also be performed to determine the rise time and/or frequency spectrum of the transients and vibrations. A fast-moving transient edge can be identified by directly measuring the rate at which the signal changes over a succession of time-spaced samples, or by comparing the sampled signal with a synthetic or recorded template of a transient. Fast-moving/high frequency energy can also be detected by looking at the frequency content (spectrum) of the signal. In terms of Fourier synthesis, high harmonics have significant magnitude in such rapid acoustic transients. Again, this characteristic can be determined by directly analyzing the spectral content, or by comparison of the spectrum with a pre-determined template spectrum.

[00242] This type of analysis can also reveal information about the speed of movement of the touch along the touch-sensitive surface, particularly if there is some profiling of the touch-sensitive surface (although this is not a requirement). Estimation of the speed of travel can be done by analysis of the signal intensity, phase or spectrum at many transducers, or by the spectrum or change of intensity, phase or spectrum at a single transducer. A speed estimate can be useful supplementary data for a touch-sensitive sensor since it can help to estimate an expected location from one scan to the next.

[00243] When a touch is moving quickly, successive reported locations from the touch-sensitive system may be quite far apart, and it may not be obvious that the reports relate to the same touch. If the speed is known to be high, based on the acoustic signal, then this relationship between successive reports can be established.

[00244] Different touch types, or specific instances of touch types can be discerned using acoustic sensors. For example, two instruments could be distinguished by virtue of the tip material, the instrument mass or by additional aspects of the instrument design which causes the vibrations in the touch-sensitive surface to be distinguishable.

[00245] Contact microphones and similar transducers can be attached to the underside of the touch-sensitive surface (i.e. the side facing away from the user) so that an uncluttered surface can be presented to the user. These would be connected to analog-to-digital conversion circuitry and the resulting time-sampled data made available to a microprocessor system. Some or all of the analysis could optionally be performed using analog electronics, but that is likely to be less preferable than digital processing.

VIII. Additional Considerations

[00246] The figures depict embodiments of the present invention for purposes of illustration only. One skilled in the art will readily recognize from the following discussion that alternative embodiments of the structures and methods illustrated herein may be employed without departing from the principles of the invention described herein.

[00247] Upon reading this disclosure, those of skill in the art will appreciate still additional alternative structural and functional designs through the disclosed principles herein. Thus, while particular embodiments and applications have been illustrated and described, it is to be understood that the disclosed embodiments are not limited to the precise construction and components disclosed herein. Various modifications, changes and variations, which will be apparent to those skilled in the art, may be made in the arrangement, operation and details of the method and apparatus disclosed herein.

What is claimed is:

1. A method for making an association between an active instrument and a detected touch event on a touch-sensitive surface, the method comprising:
 - receiving information specific to each of one or more detected touch events;
 - receiving information specific to an active instrument;
 - analyzing the information specific to the active instrument with the information specific to the detected touch events for consistency with a situation in which the active instrument caused one of the detected touch events; and
 - making an association between the active instrument and one of the detected touch events based on said analysis.
2. The method of claim 1, wherein a plurality of emitters and a plurality of detectors are arranged around the touch-sensitive surface's periphery, optical beams propagate from the plurality of emitters to the plurality of detectors by total internal reflection in an optical waveguide, the method further comprising:
 - detecting locations for the detected touch events based on disturbances of the optical beams as a result of frustrated total internal reflection coupling energy out of the optical waveguide at the detected touch events.
3. The method of claim 2, wherein:
 - the information specific to each of the detected touch events comprises transmittance of the optical beams disturbed by the detected touch event;
 - the information specific to the active instrument comprises a strength of optical coupling between the active instrument and the optical waveguide; and
 - analyzing the information specific to the active instrument with the information specific to the detected touch events comprises determining consistency between the transmittance of the optical beams disturbed by the detected touch events and the strength of optical coupling between the active instrument and the optical waveguide.
4. The method of claim 3, wherein the active instrument injects light into the optical waveguide, the method further comprising:

determining the strength of optical coupling between the active instrument and the optical waveguide based on coupling of the light injected from the active instrument into the optical waveguide.

5. The method of claim 3, wherein the active instrument detects optical beams coupled out of the optical waveguide, the method further comprising:
determining the strength of optical coupling between the active instrument and the optical waveguide based on the optical beams coupled out of the optical waveguide by frustrated total internal reflection and into the active instrument.
6. The method of claim 3, wherein:
the information specific to each of the detected touch events comprises time variation of transmittance of the optical beams disturbed by the detected touch event;
the information specific to the active instrument comprises time variation of a strength of optical coupling between the active instrument and the optical waveguide;
and
analyzing the information specific to the active instrument with the information specific to the detected touch events comprises determining consistency between the time variation of transmittance of the optical beams disturbed by the detected touch events and the time variation of the strength of optical coupling between the active instrument and the optical waveguide.
7. The method of claim 2, wherein
the information specific to each of the detected touch events comprises a movement over time of the detected touch event;
the information specific to the active instrument comprises a movement over time of the active instrument; and
analyzing the information specific to the active instrument with the information specific to the detected touch events comprises determining consistency between the movement of the detected touch events and the movement of the active instrument.
8. The method of claim 7, wherein the movement of the active instrument is captured by a motion sensor in the active instrument.

9. The method of claim 8, wherein receiving the information specific to the active instrument occurs on a delayed basis.
10. The method of claim 2, wherein
the information specific to each of the detected touch events comprises a location of the detected touch event;
the active instrument injects light into the optical waveguide according to an emission pattern, and the information specific to the active instrument comprises the emission pattern for the active instrument and further comprises a pattern of the injected light detected by the plurality of detectors; and
analyzing the information specific to the active instrument with the information specific to the detected touch events comprises determining consistency between the pattern of injected light that is actually detected and the patterns that would be produced by the emission pattern centered at the locations of the detected touch events.
11. The method of claim 10, wherein determining consistency between the pattern of injected light that is actually detected and the patterns that would be produced by the emission pattern centered at the locations of the detected touch events comprises:
using templates for the patterns that would be produced by the emission pattern centered at different locations.
12. The method of claim 10, wherein determining consistency between the pattern of injected light that is actually detected and the patterns that would be produced by the emission pattern centered at the locations of the detected touch events comprises:
estimated an approximate location for the active instrument based on the emission pattern for the active instrument and the actual pattern of injected light detected by the plurality of detectors; and
determining consistency between the estimated approximate location for the active instrument and the locations of the detected touch events.
13. The method of claim 10, wherein:
the information specific to each of the detected touch events comprises time variation of location of the detected touch event;

the active instrument injects light into the optical waveguide according to an emission pattern, and the information specific to the active instrument comprises the emission pattern for the active instrument and further comprises a time variation of a pattern of the injected light detected by the plurality of detectors; and

analyzing the information specific to the active instrument with the information specific to the detected touch events comprises determining consistency between the time variation of the pattern of injected light that is actually detected and the time variations of the patterns that would be produced by the emission pattern centered at the time-varying locations of the detected touch events.

14. The method of claim 2, wherein the active instrument injects light into the optical waveguide according to an emission pattern, the method further comprising:
identifying the active instrument based on the injected light detected by the plurality of detectors in comparison to the emission pattern.
15. The method of claim 14, wherein the emission pattern includes spatial variation of the injected light as a function of angle.
16. The method of claim **Error! Reference source not found.**, wherein the emission pattern includes intensity modulation of the injected light over time.
17. The method of claim **Error! Reference source not found.**, wherein the emission pattern includes wavelength variation of the injected light over time.
18. The method of claim **Error! Reference source not found.**, wherein the emission pattern includes spatial variation of the injected light over time.
19. The method of claim 2, wherein the active instrument injects light into the optical waveguide according to an emission pattern, the method further comprising:
determining an orientation of the active instrument based on the injected light detected by the plurality of detectors in comparison to the emission pattern.

20. A non-transitory computer-readable medium comprising computer program instructions that when executed by a processor of a touch-sensitive device causes the processor to perform steps comprising:
- receiving information specific to each of one or more detected touch events;
 - receiving information specific to an active instrument;
 - analyzing the information specific to the active instrument with the information specific to the detected touch events for consistency with a situation in which the active instrument caused one of the detected touch events; and
 - making an association between the active instrument and one of the detected touch events based on said analysis.
21. An optical touch-sensitive device comprising:
- a surface for which one or more touch events are to be detected;
 - a detector configured to detect the one or more touch events; and
 - a touch event processor coupled, directly or indirectly, to the detector, the touch event processor configured to perform steps comprising:
 - receiving information specific to each of the one or more detected touch events,
 - receiving information specific to an active instrument,
 - analyzing the information specific to the active instrument with the information specific to the detected touch events for consistency with a situation in which the active instrument caused one of the detected touch events, and
 - making an association between the active instrument and one of the detected touch events based on said analysis.

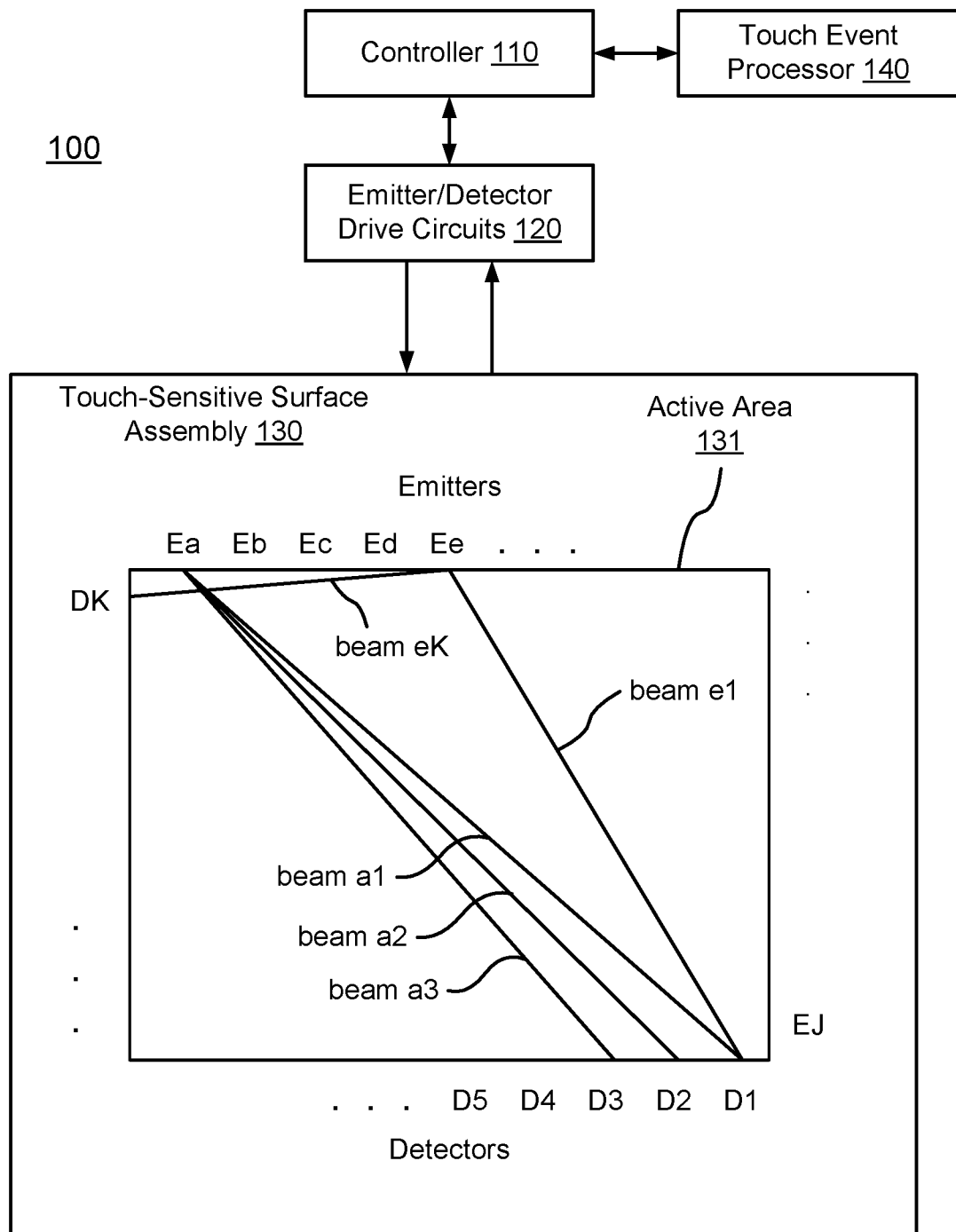


FIG. 1

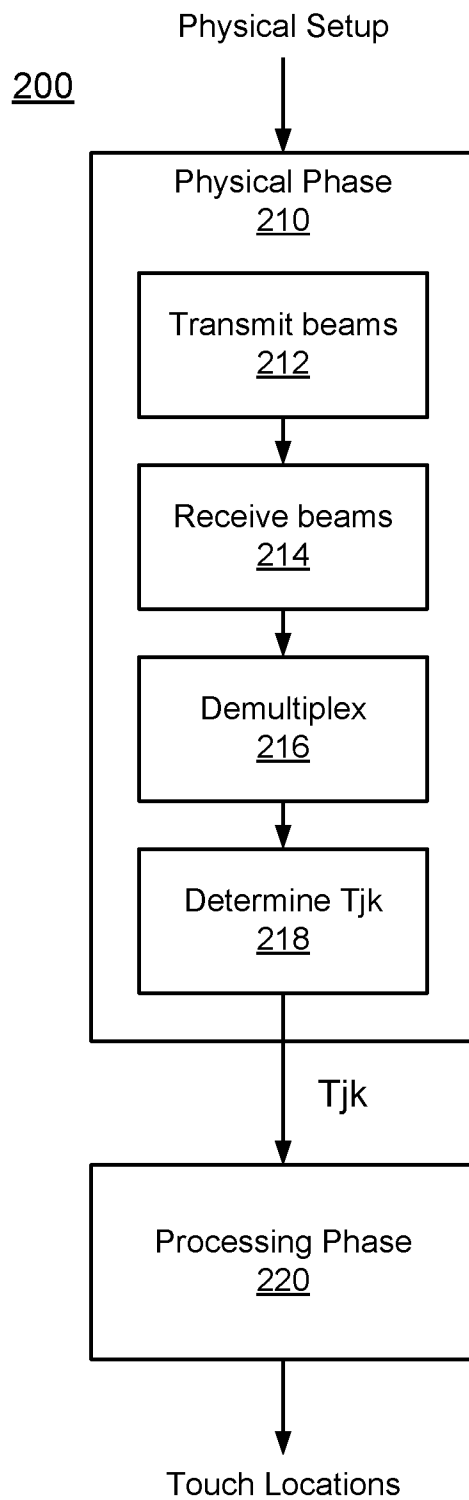


FIG. 2

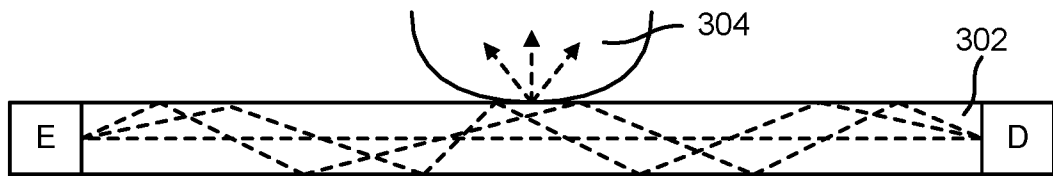


FIG. 3A

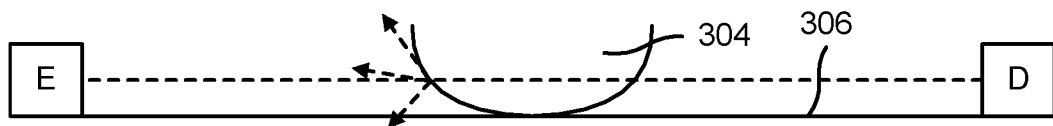


FIG. 3B

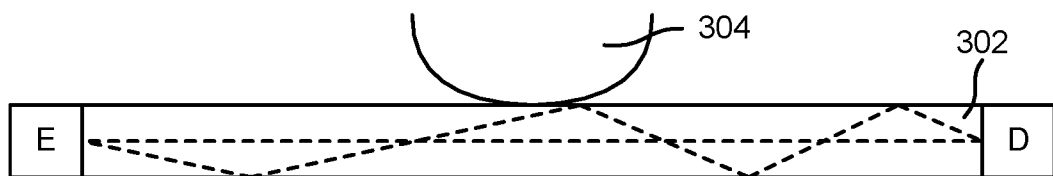


FIG. 3C

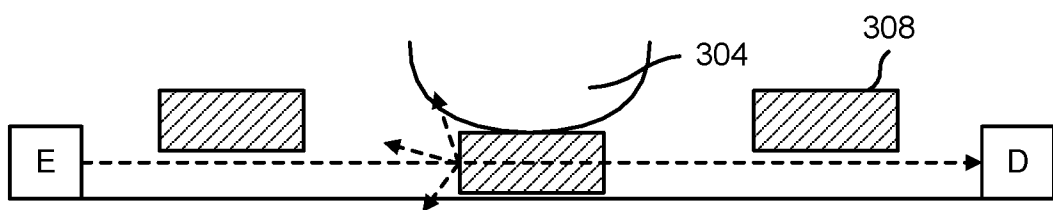


FIG. 3D

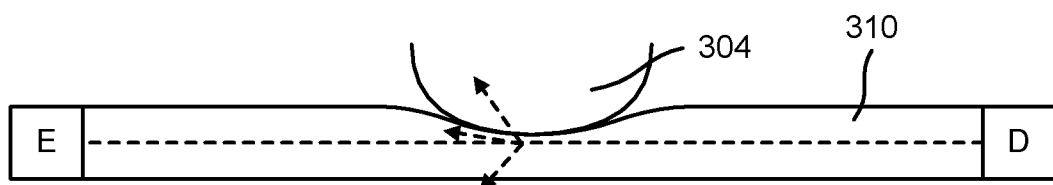


FIG. 3E

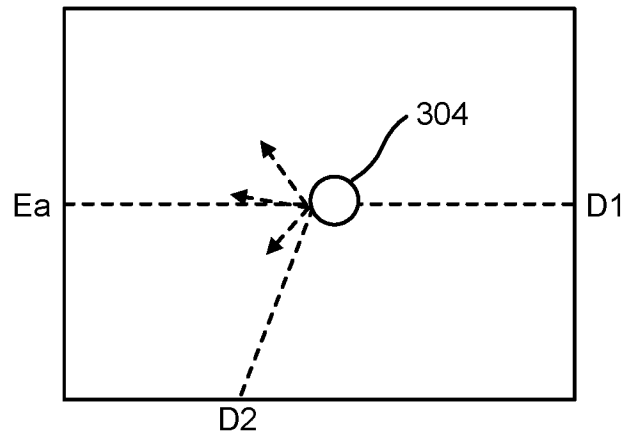


FIG. 3F

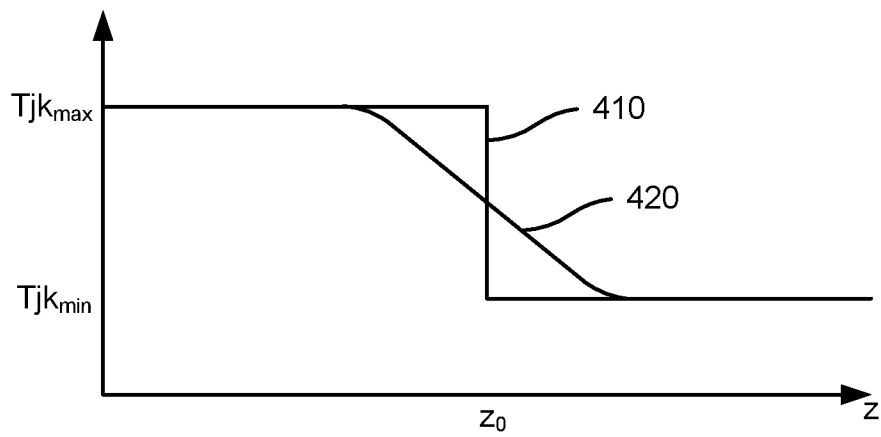


FIG. 4

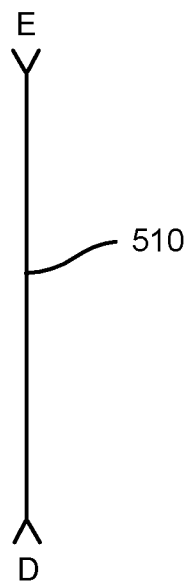


FIG. 5A

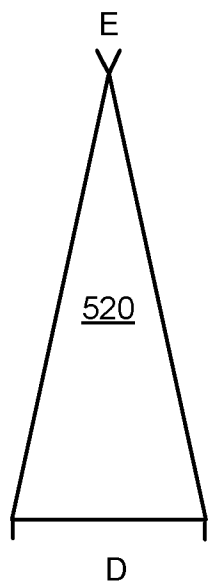


FIG. 5B

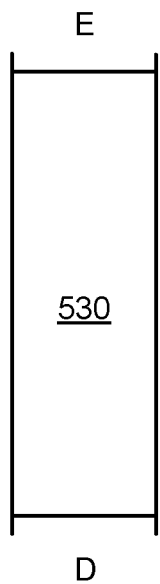


FIG. 5C

5/23

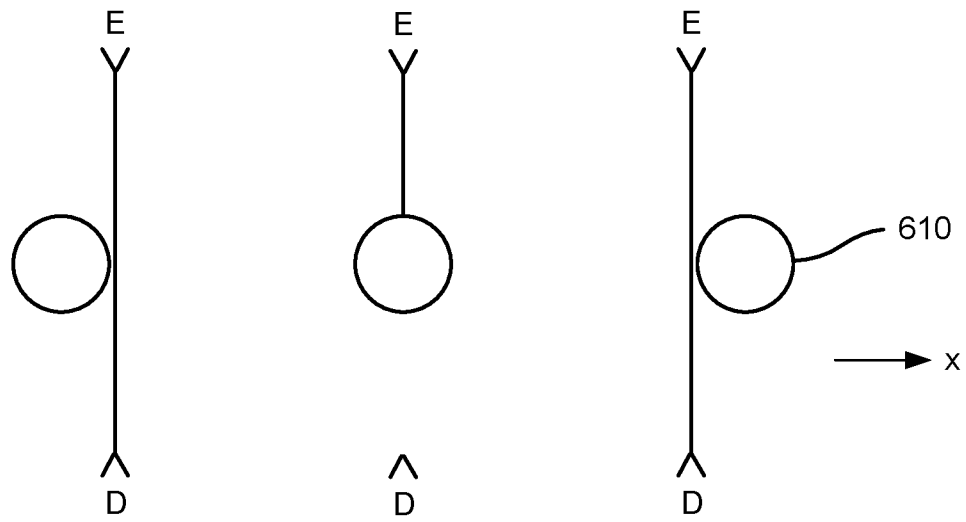


FIG. 6A

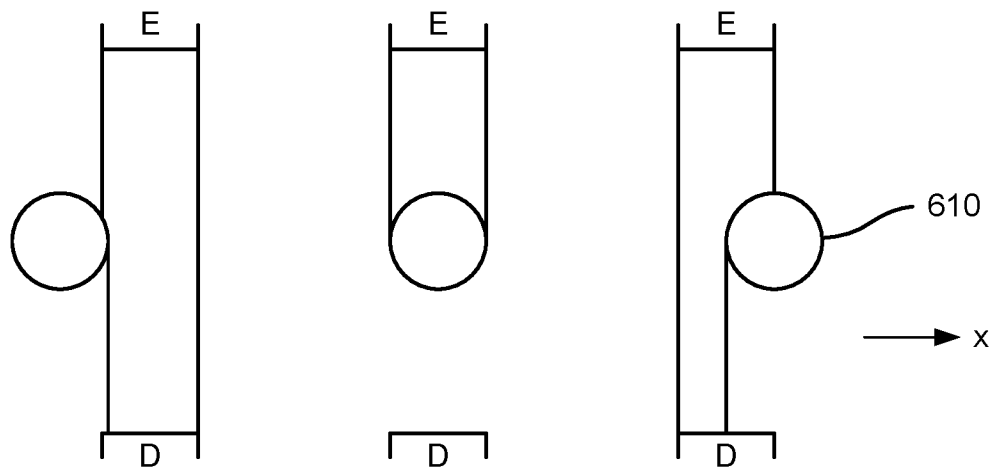


FIG. 6B

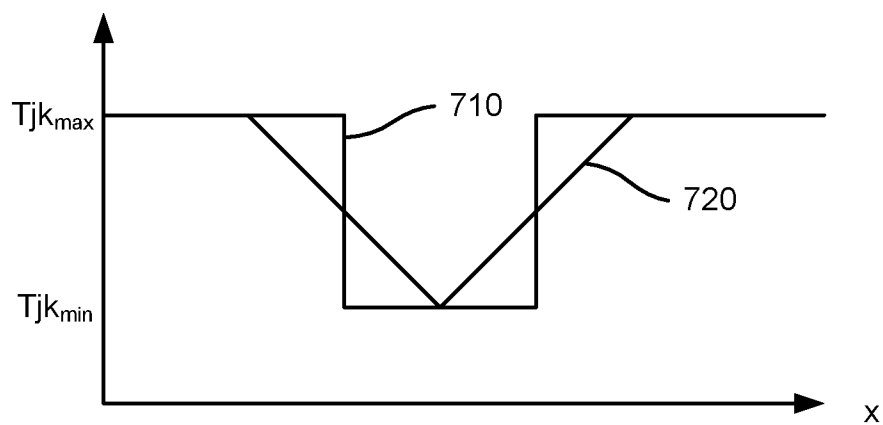


FIG. 7

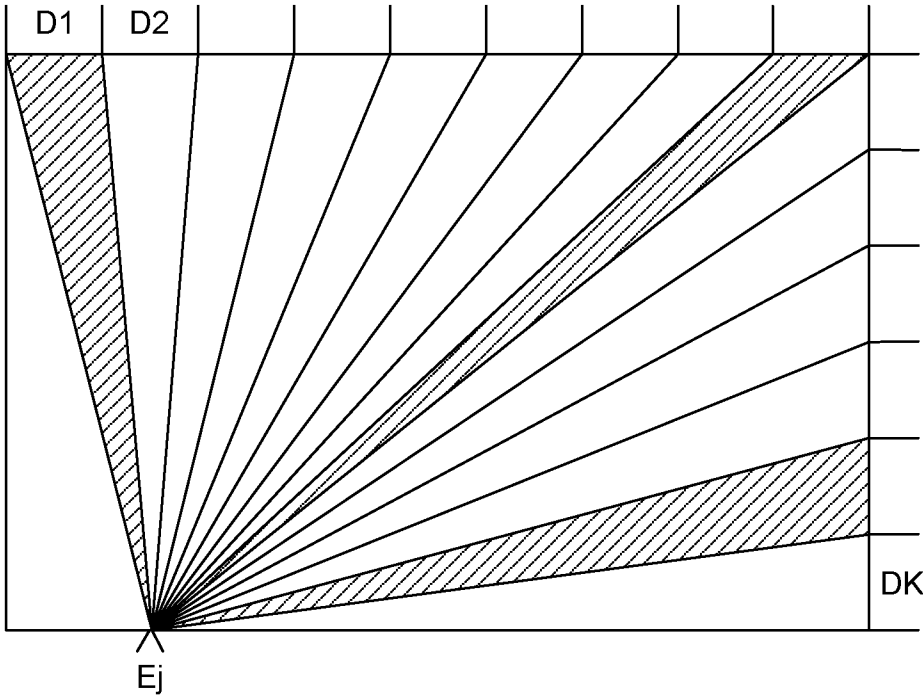


FIG. 8A

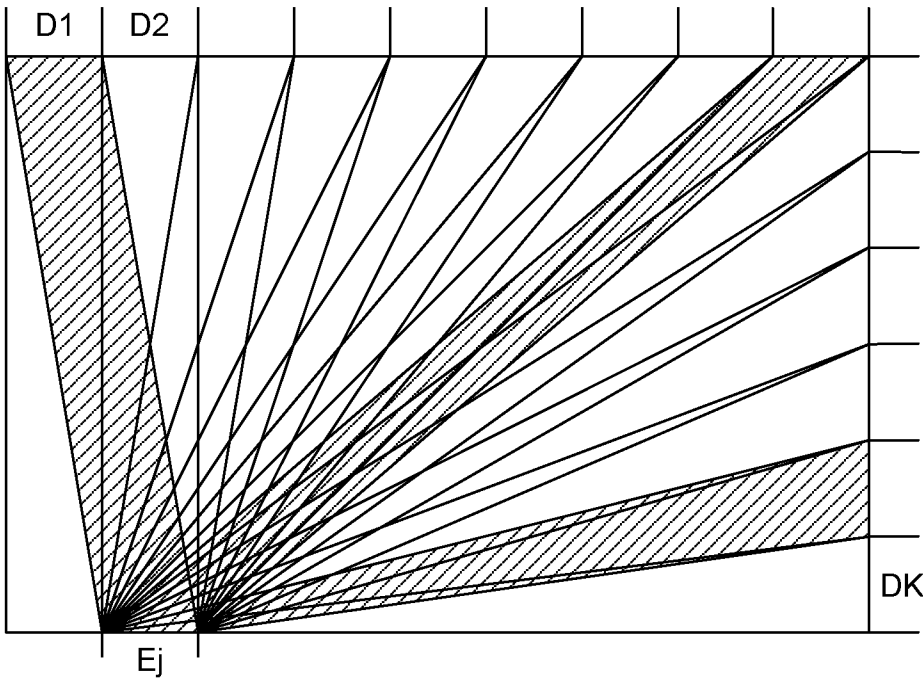


FIG. 8B

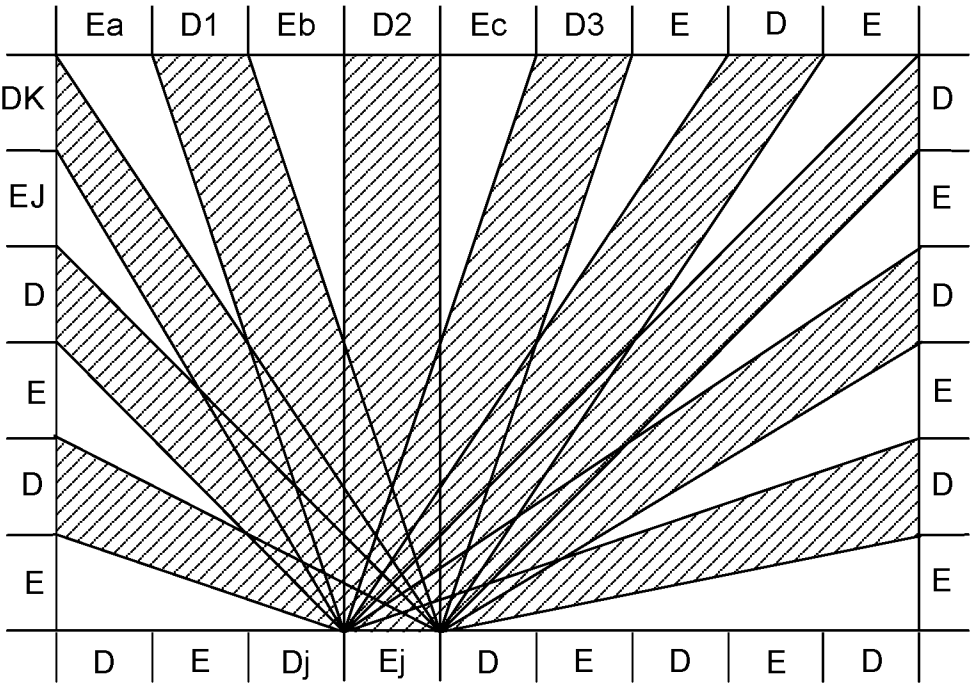


FIG. 8C



FIG. 9A



FIG. 9B

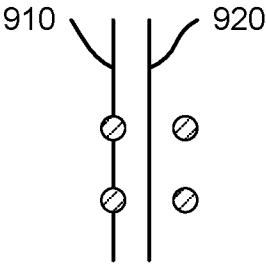


FIG. 9C

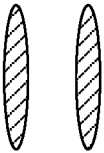


FIG. 9D

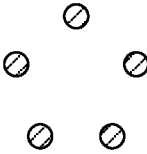


FIG. 9E

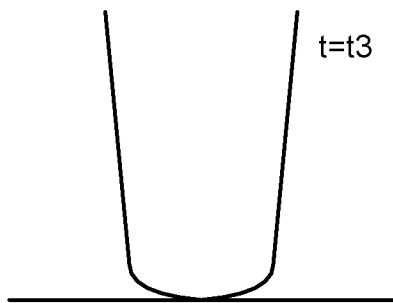
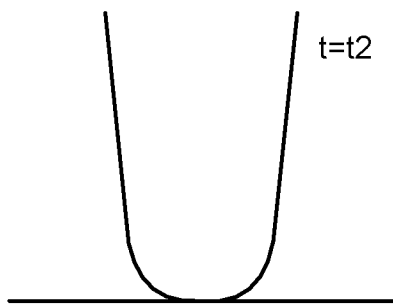
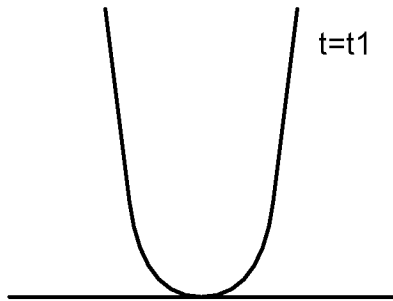


FIG. 10A

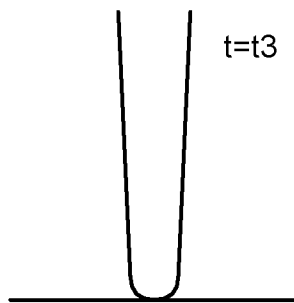
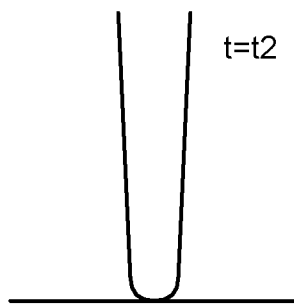
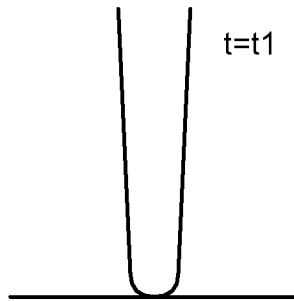


FIG. 10B

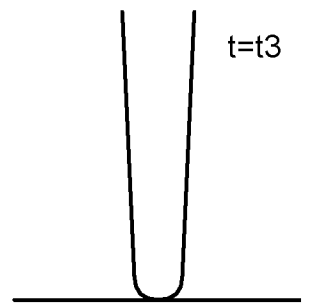
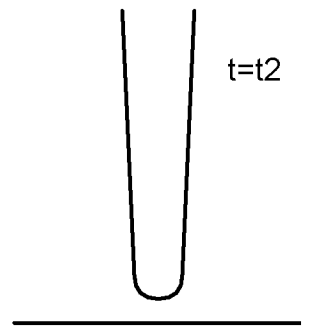
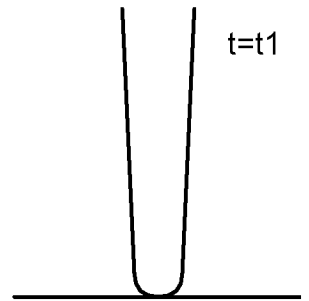


FIG. 10C

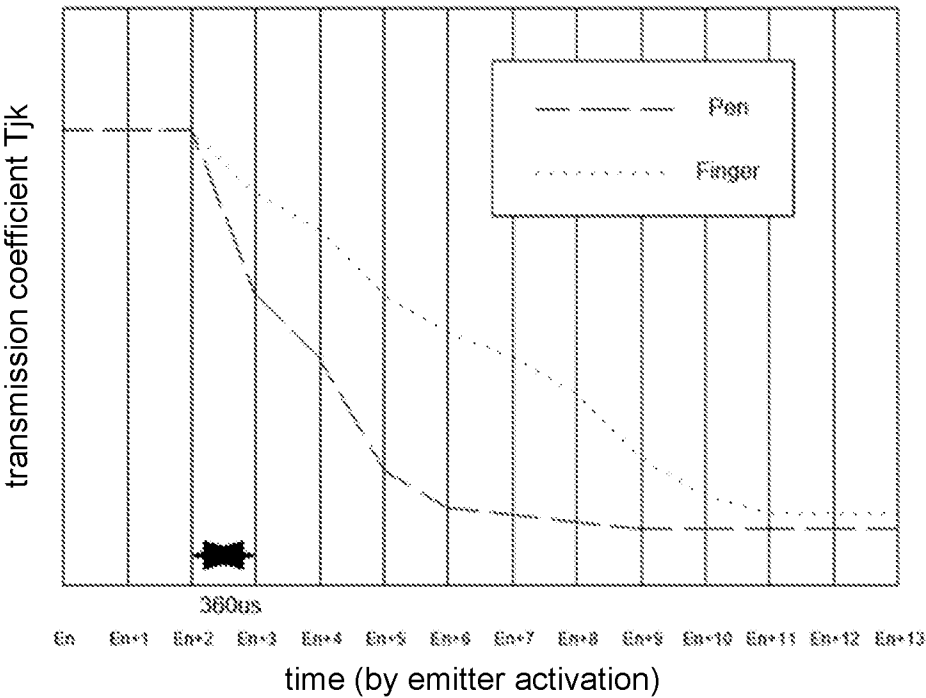


FIG. 10D

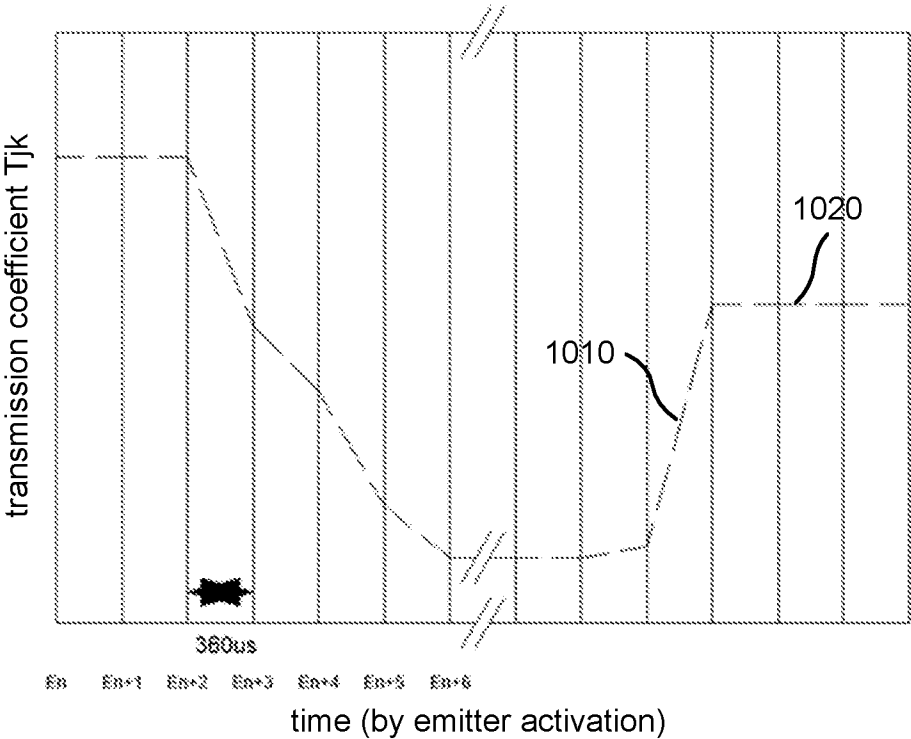


FIG. 10E

10/23

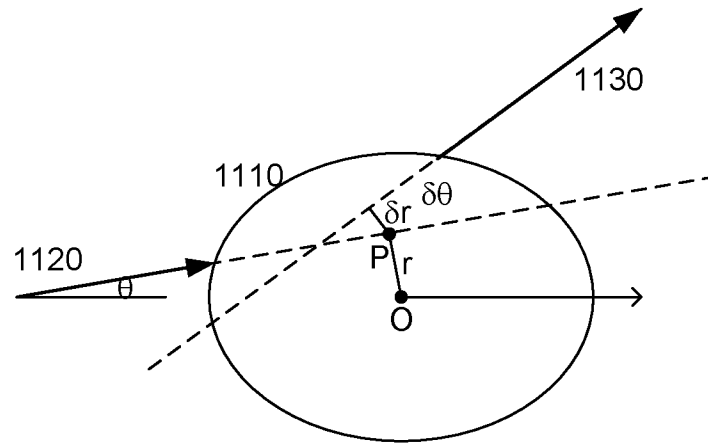


FIG. 11

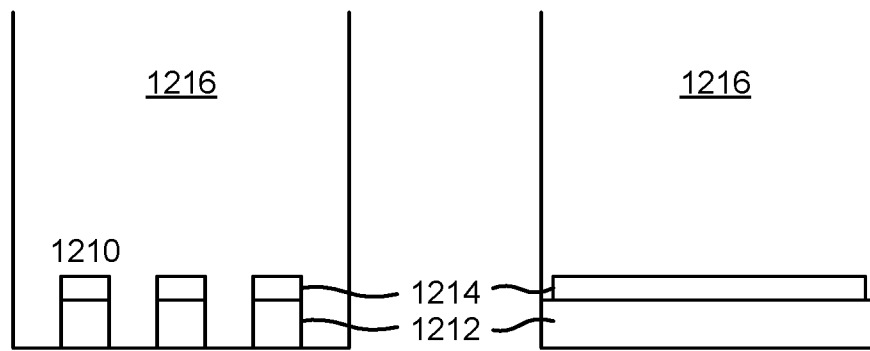


FIG. 12A

FIG. 12B

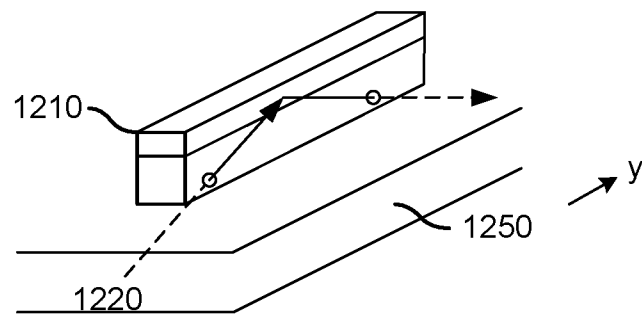
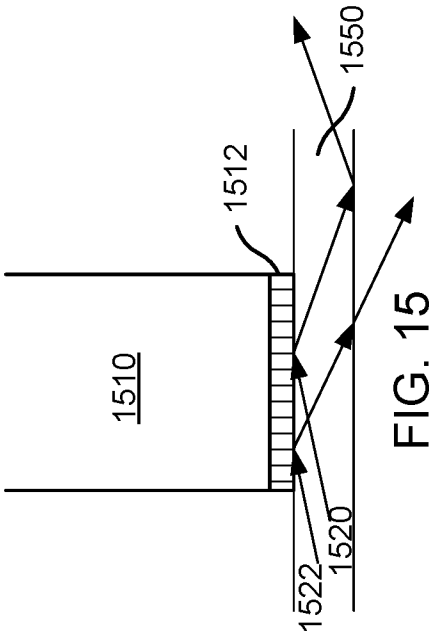
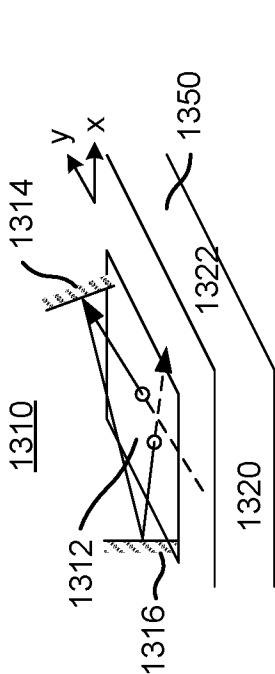
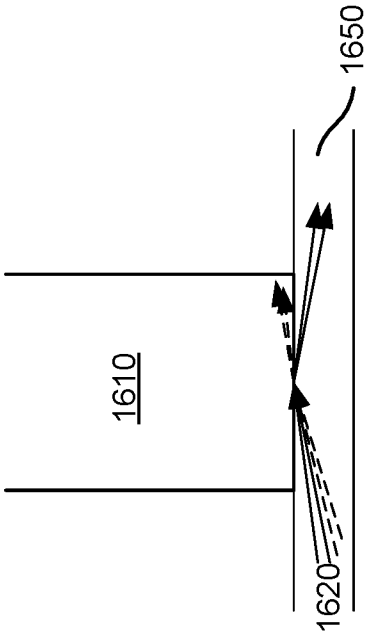
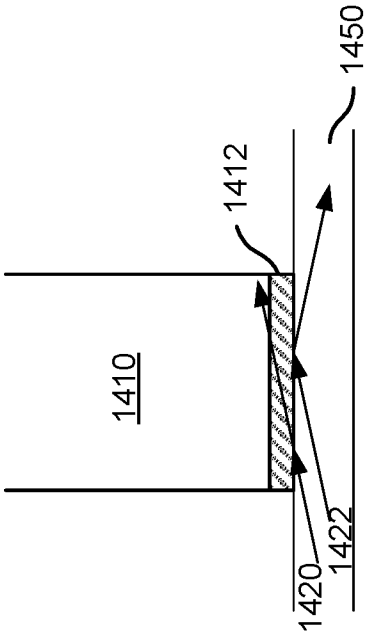
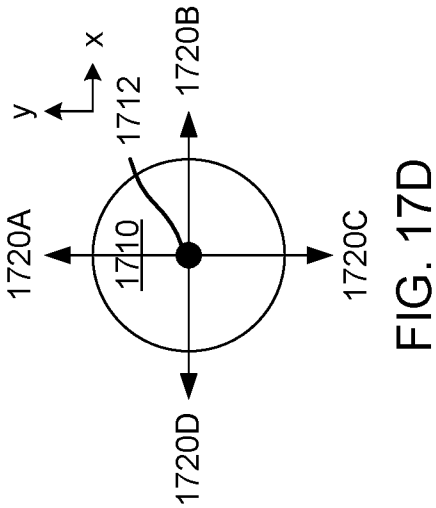
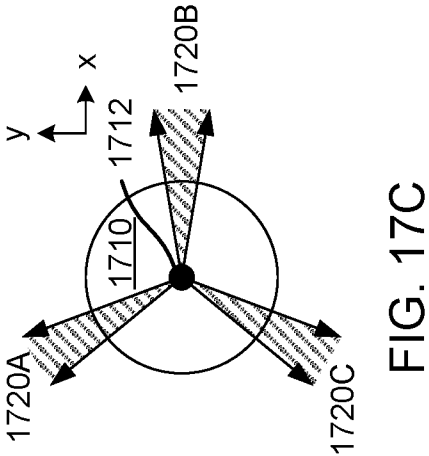
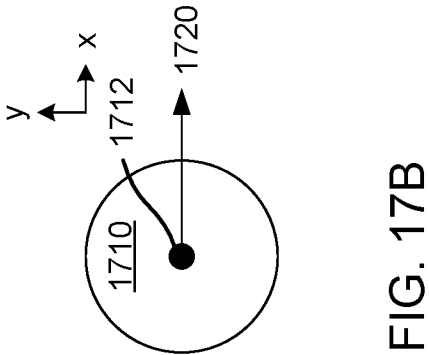
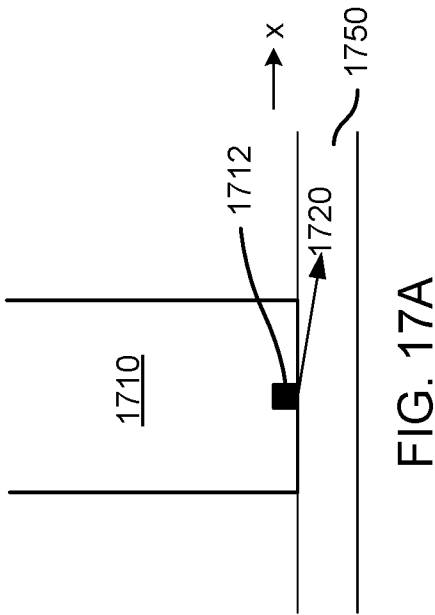


FIG. 12C





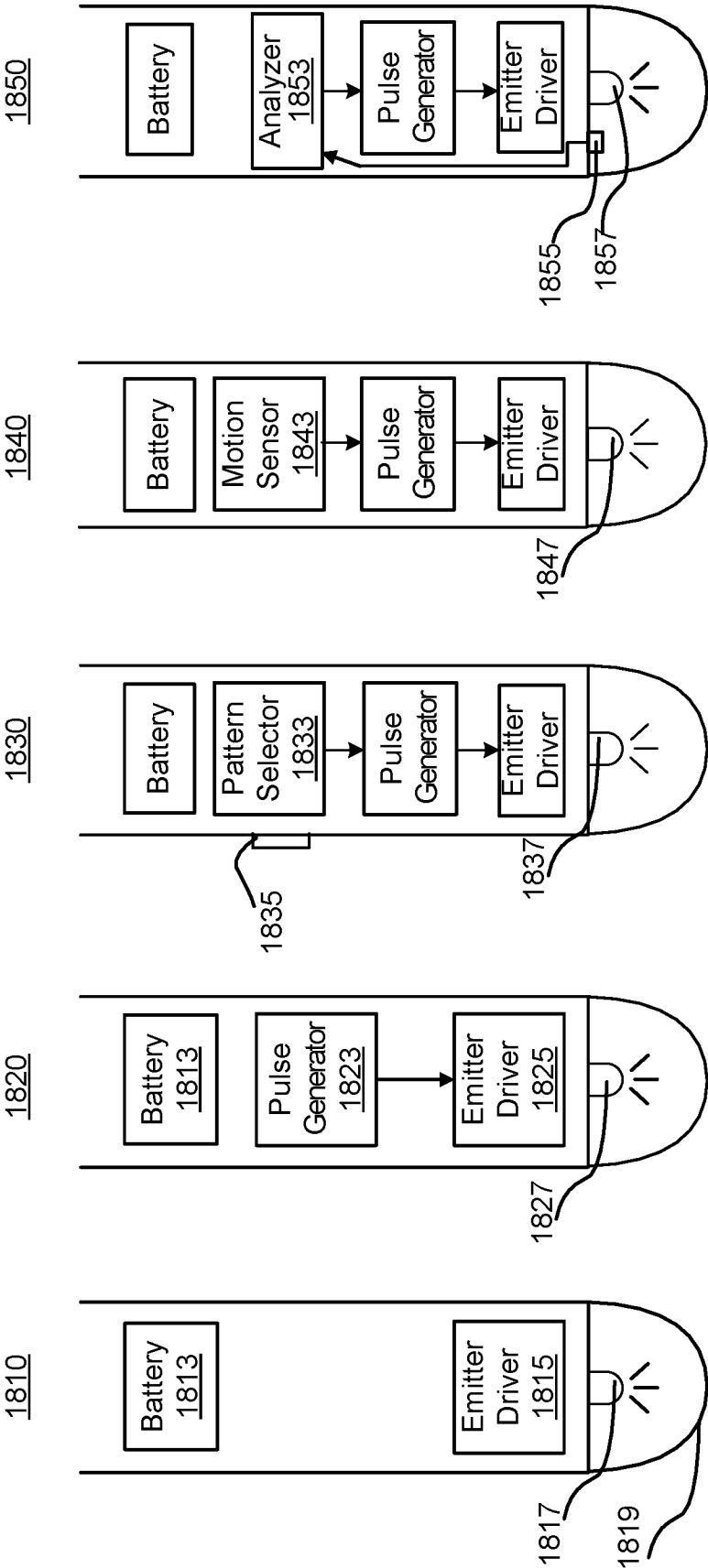


FIG. 18A

FIG. 18B

FIG. 18C

FIG. 18D

FIG. 18E

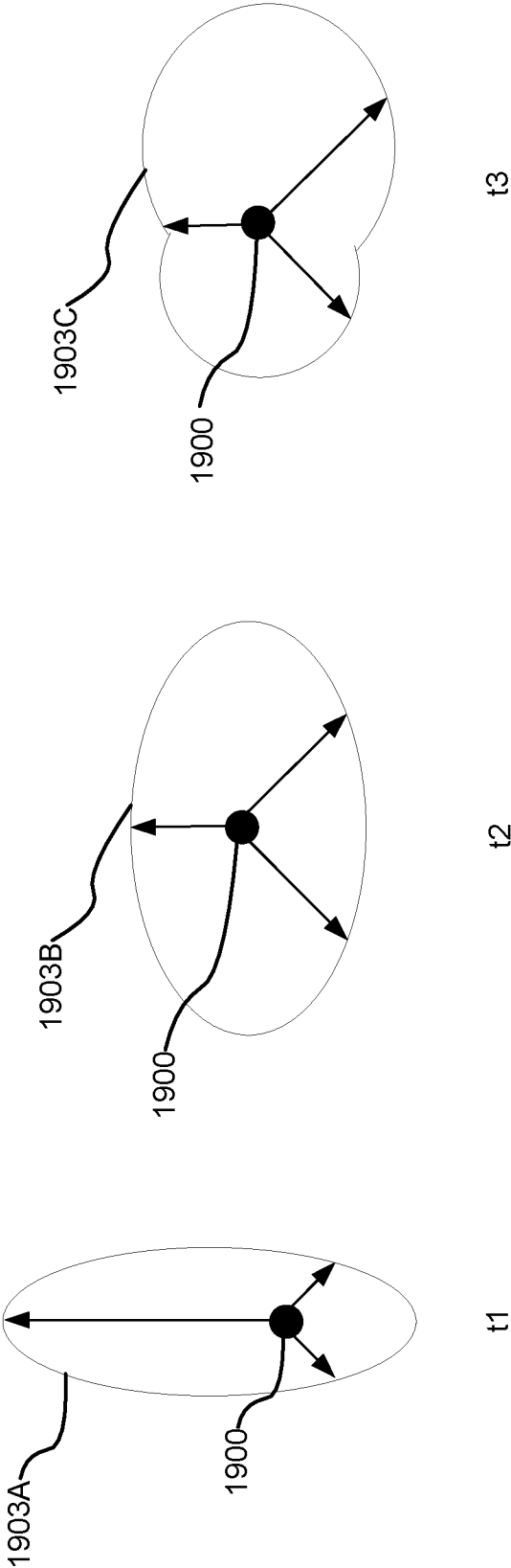


FIG. 19A

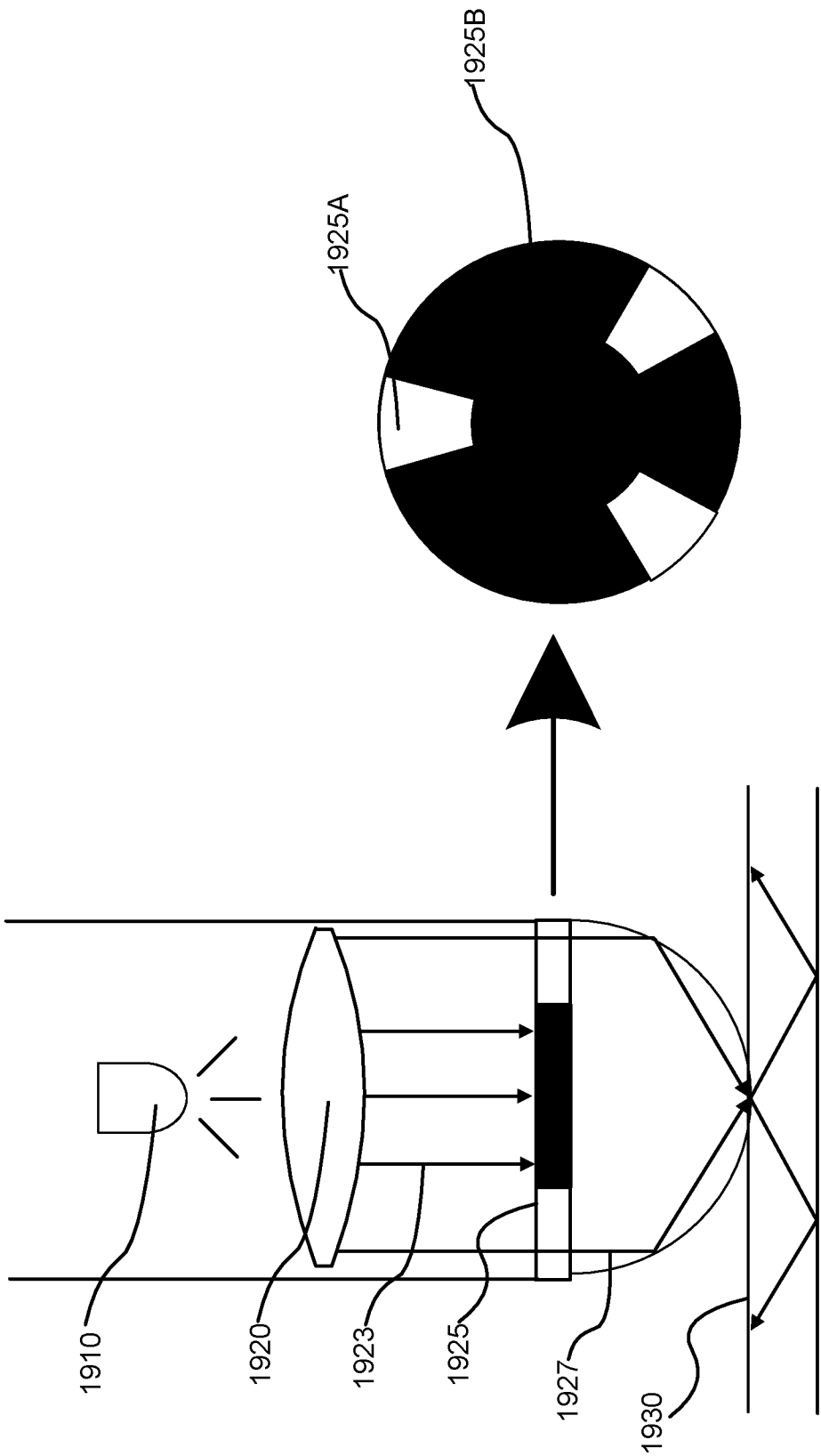


FIG. 19C

FIG. 19B

16/23

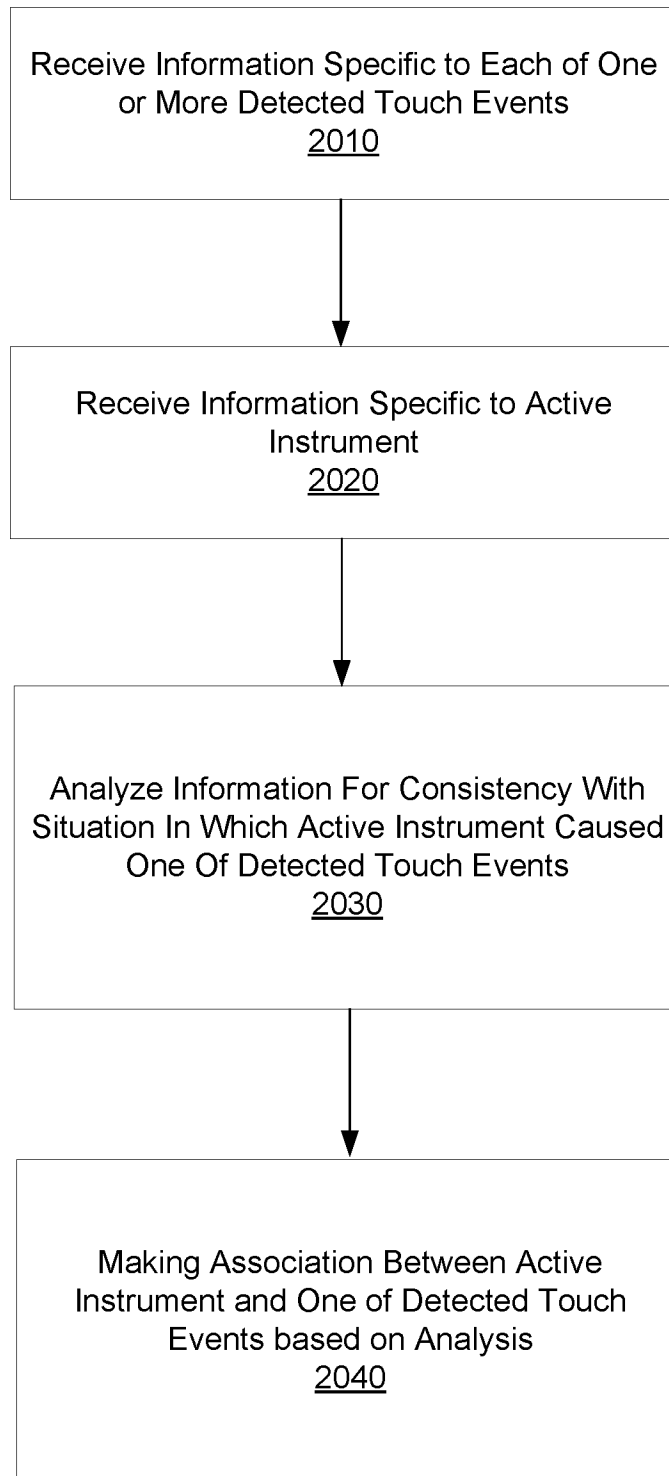
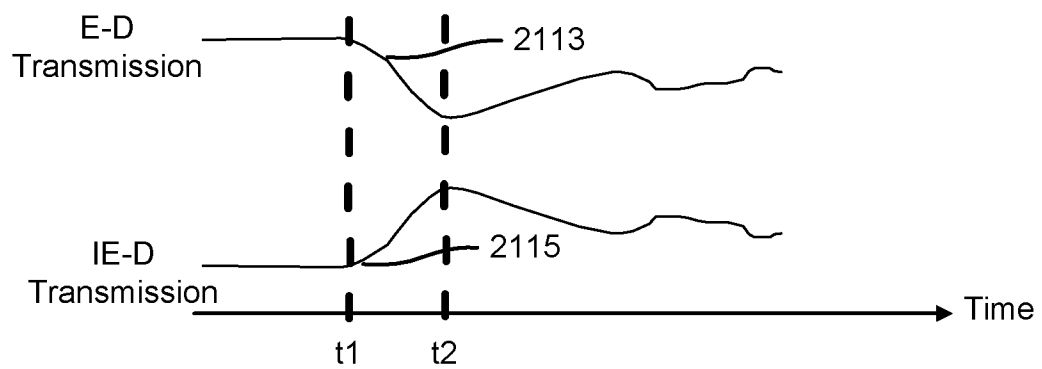
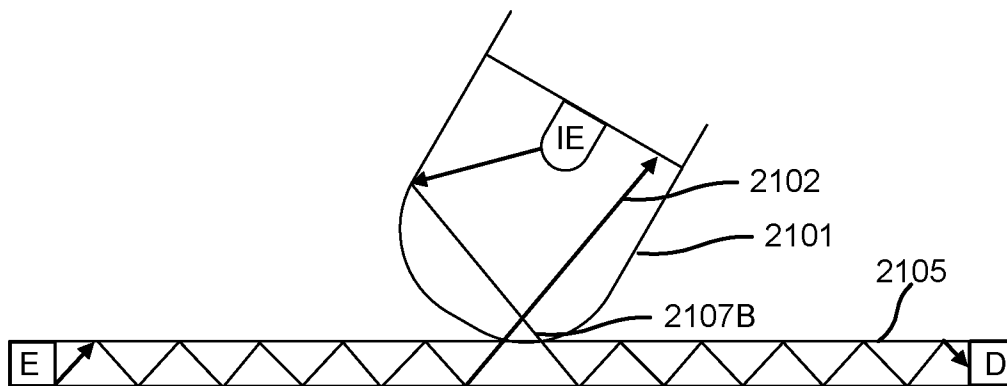
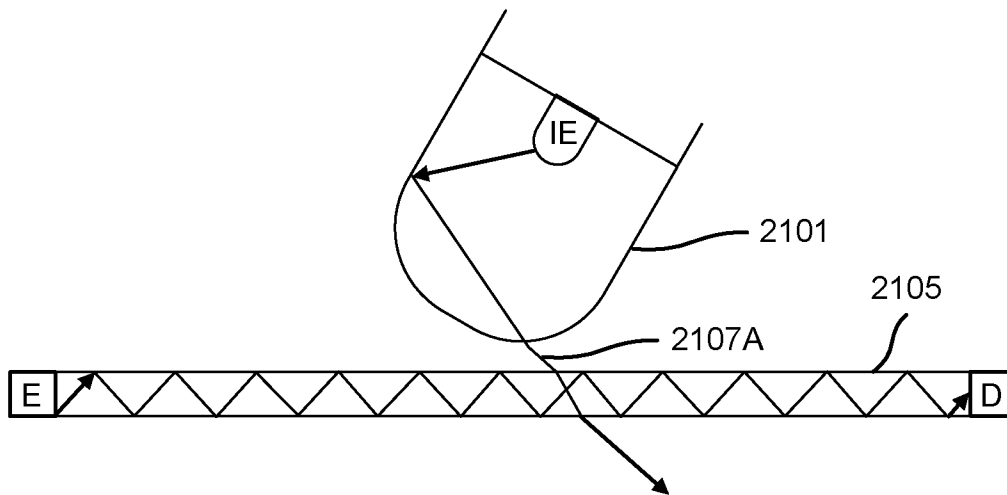
2000

FIG. 20

17/23



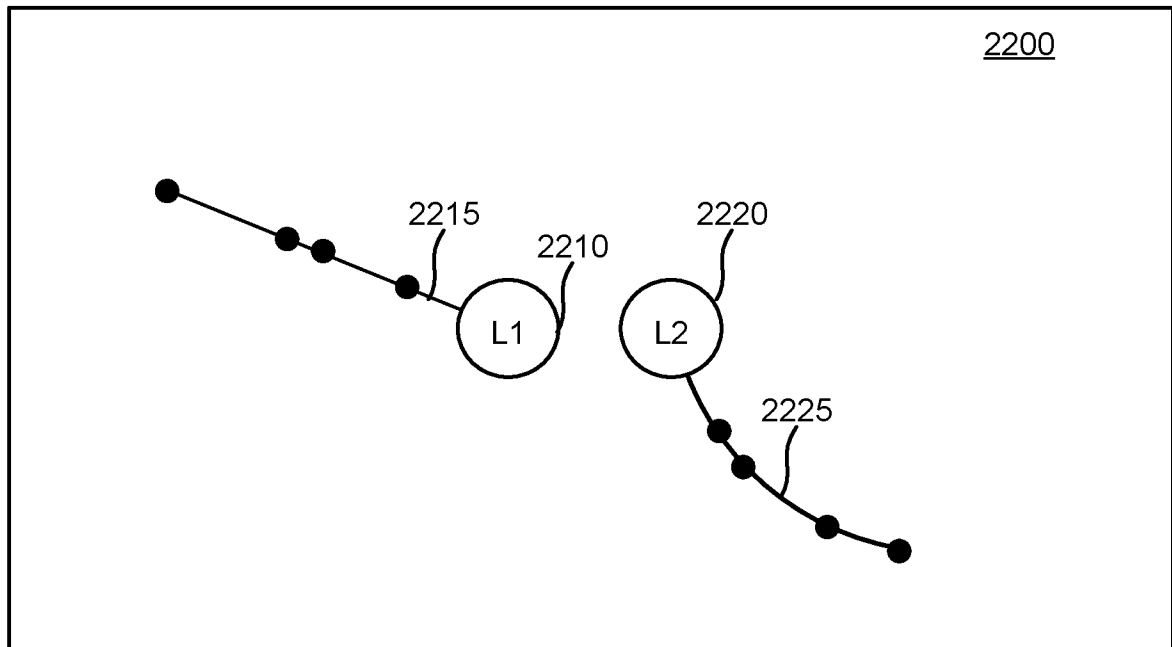


FIG. 22A

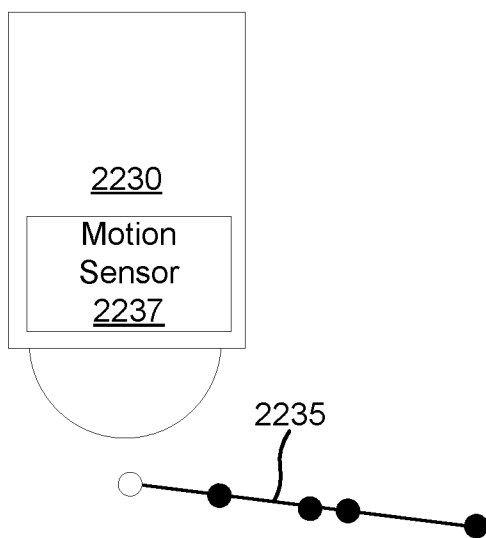


FIG. 22B

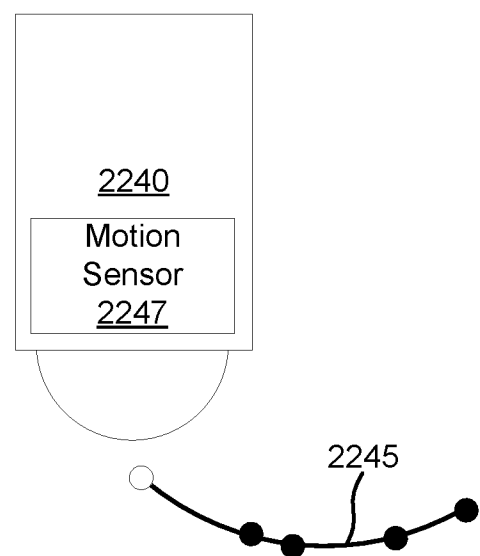


FIG. 22C

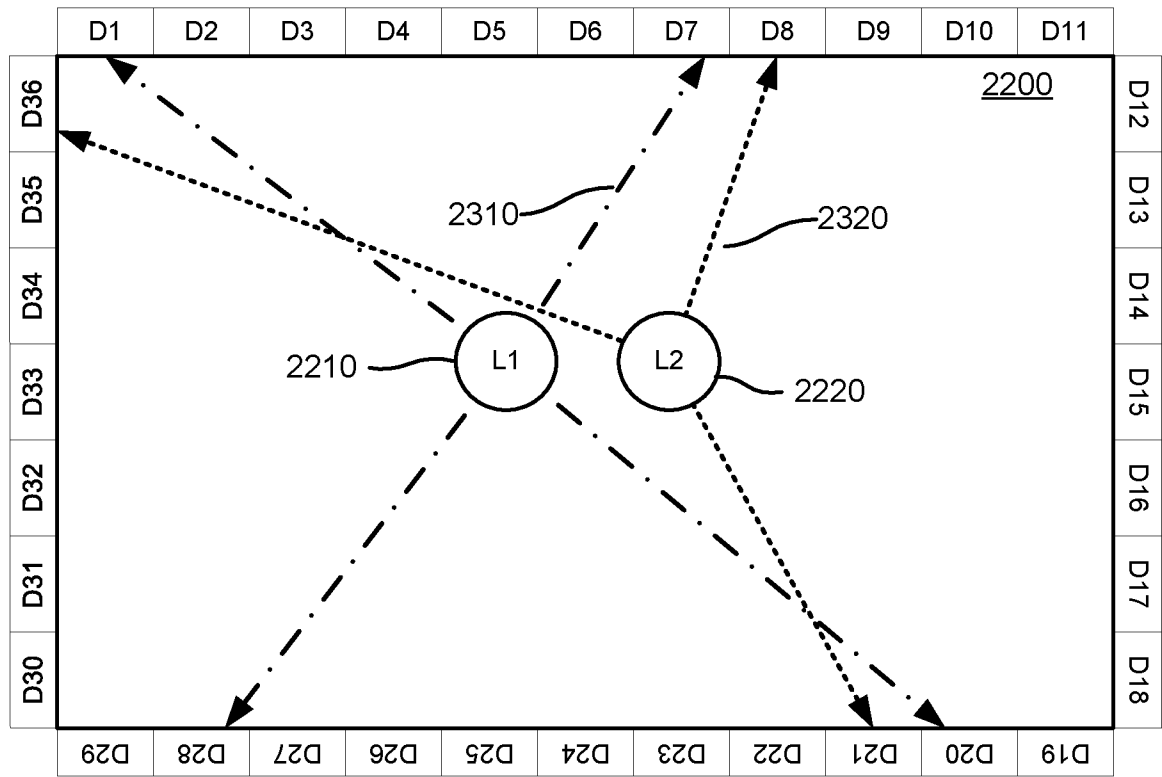


FIG. 23A

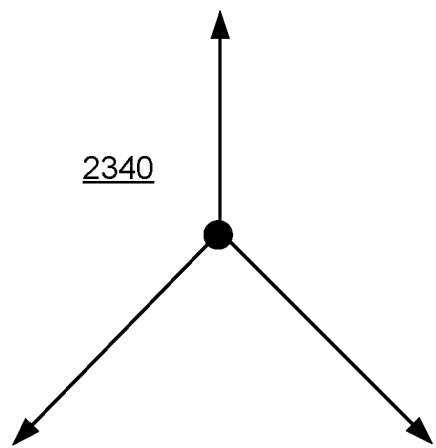


FIG. 23B

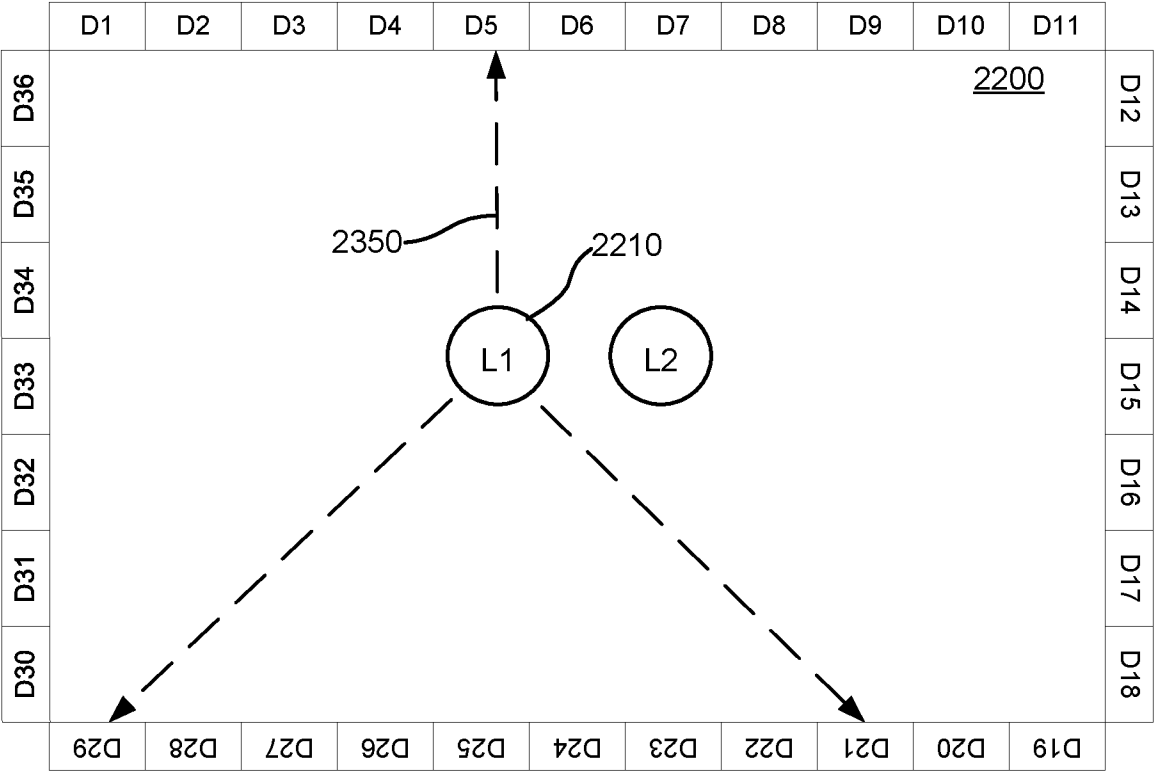


FIG. 23C

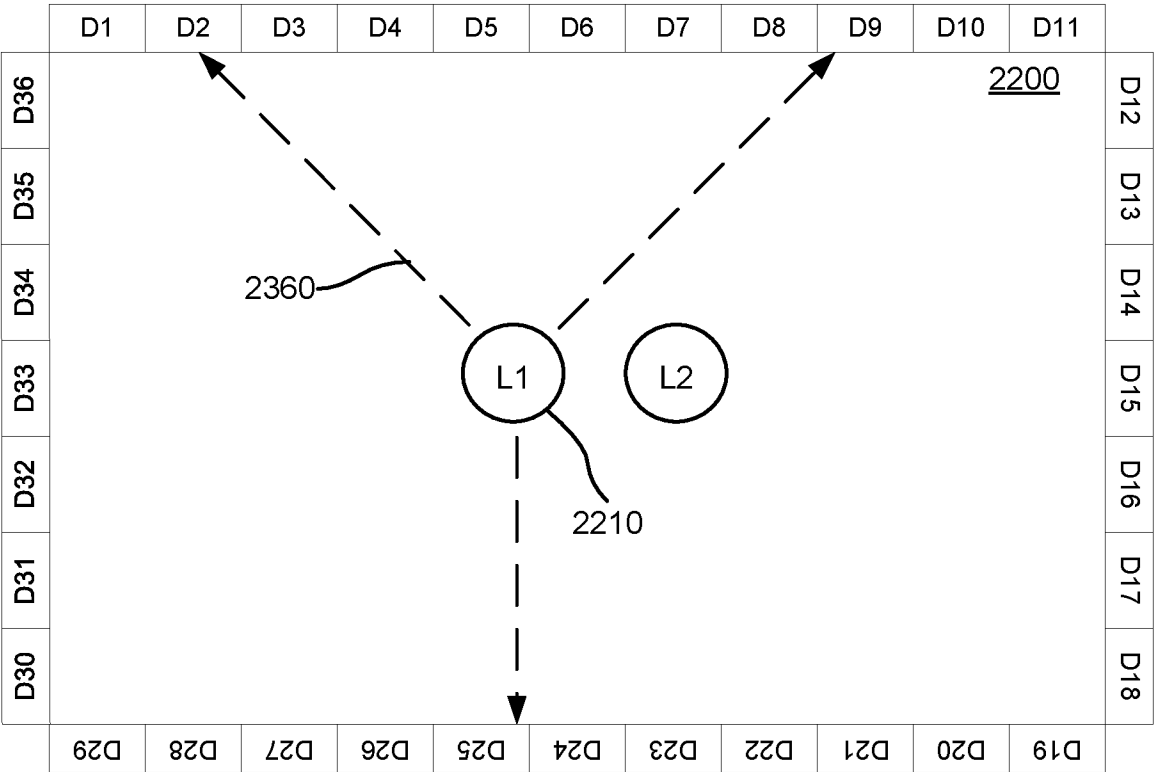


FIG. 23D

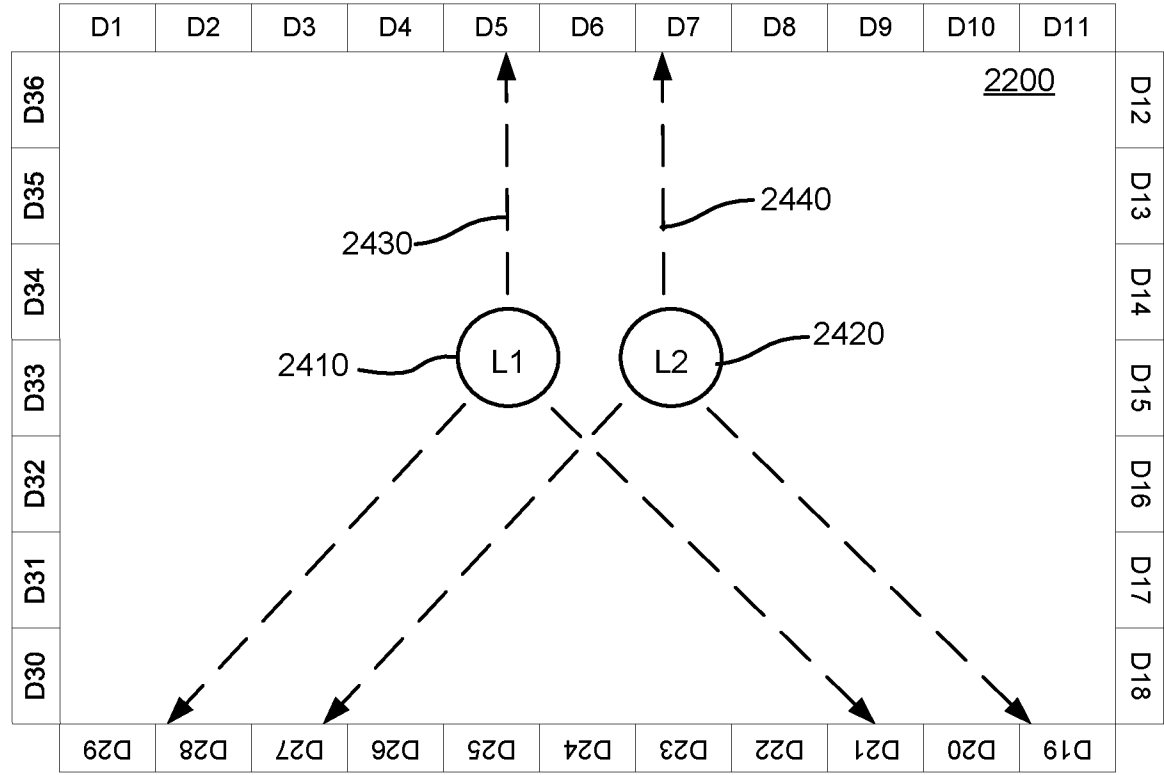


FIG. 24

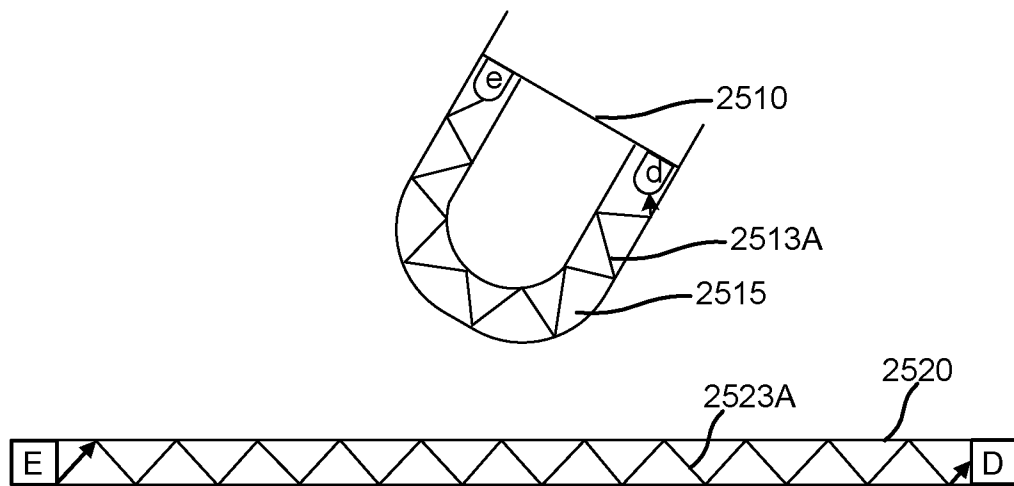


FIG. 25A

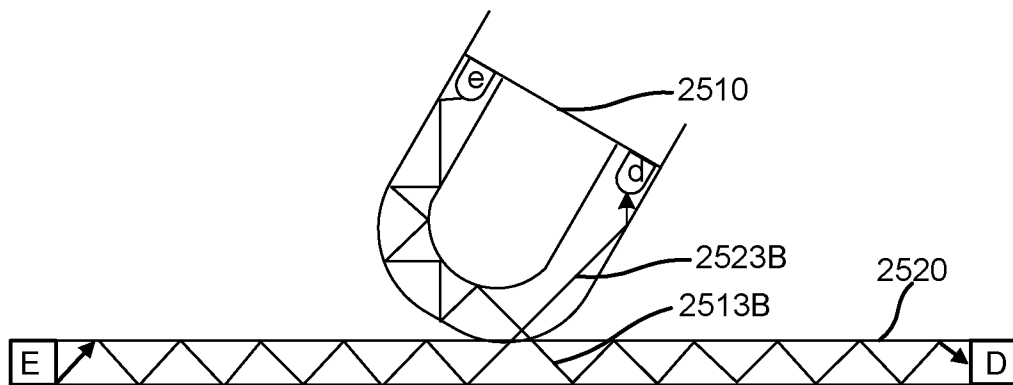


FIG. 25B

23/23

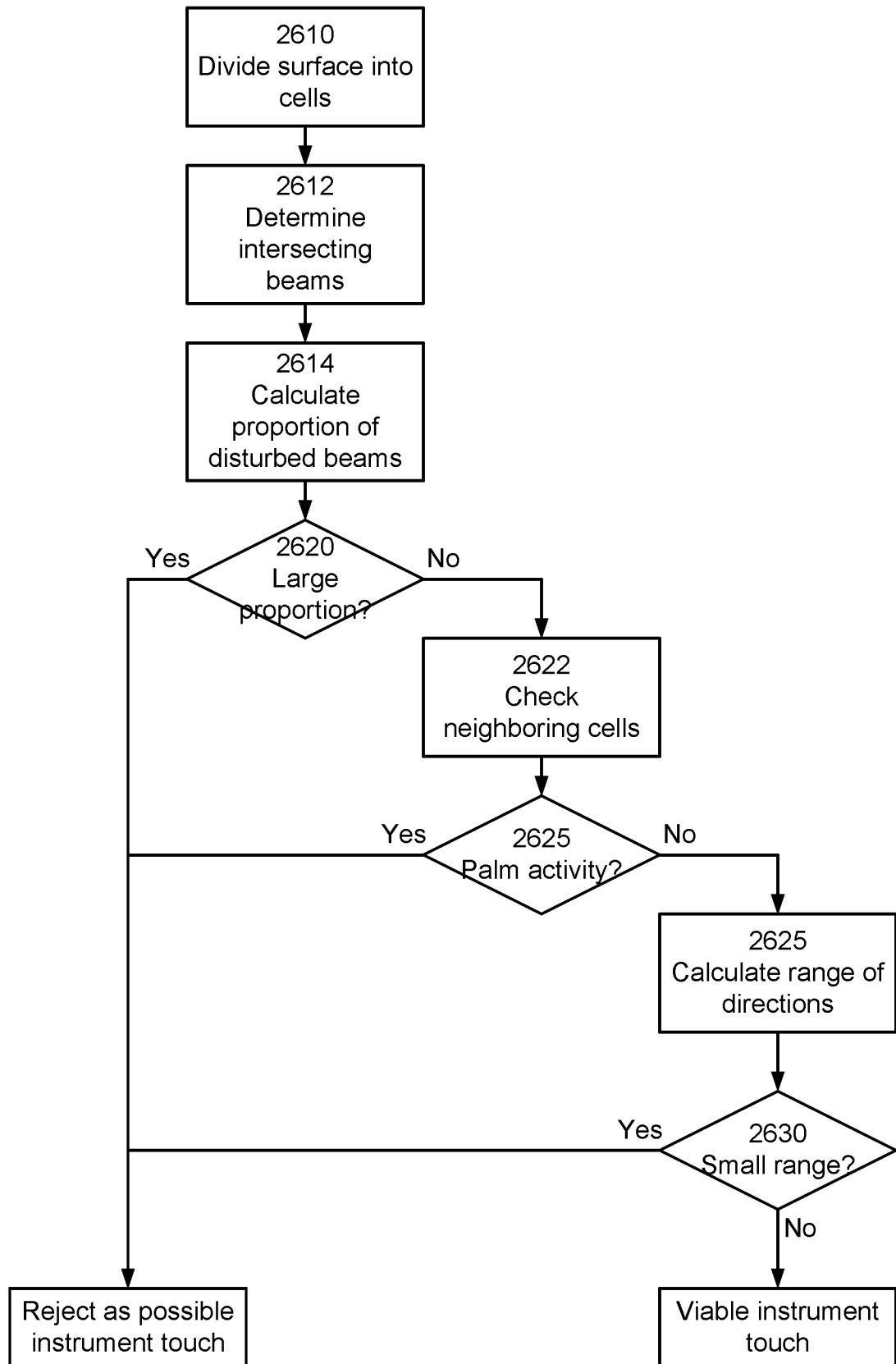


FIG. 26

INTERNATIONAL SEARCH REPORT

International application No
PCT/IB2017/000699

A. CLASSIFICATION OF SUBJECT MATTER
INV. G06F3/042
ADD. G06F3/0354

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)
G06F

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

EPO-Internal, WPI Data

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	US 2016/062549 A1 (DRUMM OWEN [IE] ET AL) 3 March 2016 (2016-03-03) paragraph [0048] - paragraph [0049] paragraph [0068] paragraph [0156] paragraph [0175] - paragraph [0193] paragraph [0183] figures 1-3, 8, 17	1-21
A	US 2014/152624 A1 (PIOT JULIEN [CH] ET AL) 5 June 2014 (2014-06-05) the whole document	1-21
A	WO 2014/027241 A2 (RAPT IP LTD; DRUMM OWEN [IE]) 20 February 2014 (2014-02-20) the whole document	1-21
	-/-	



Further documents are listed in the continuation of Box C.



See patent family annex.

* Special categories of cited documents :

"A" document defining the general state of the art which is not considered to be of particular relevance

"E" earlier application or patent but published on or after the international filing date

"L" document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)

"O" document referring to an oral disclosure, use, exhibition or other means

"P" document published prior to the international filing date but later than the priority date claimed

"T" later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention

"X" document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone

"Y" document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art

"&" document member of the same patent family

Date of the actual completion of the international search

2 October 2017

Date of mailing of the international search report

13/10/2017

Name and mailing address of the ISA/

European Patent Office, P.B. 5818 Patentlaan 2
NL - 2280 HV Rijswijk
Tel. (+31-70) 340-2040,
Fax: (+31-70) 340-3016

Authorized officer

Leineweber, Hubert

INTERNATIONAL SEARCH REPORT

International application No

PCT/IB2017/000699

C(Continuation). DOCUMENTS CONSIDERED TO BE RELEVANT		
Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
A	US 2012/218229 A1 (DRUMM OWEN [IE]) 30 August 2012 (2012-08-30) the whole document -----	1-21
A	US 2016/098152 A1 (DRUMM OWEN [IE] ET AL) 7 April 2016 (2016-04-07) the whole document -----	1-21
A	CN 101 414 225 A (GUANGDONG VTRON TECHNOLOGY CO [CN]) 22 April 2009 (2009-04-22) abstract; figures 1-5 -----	1-21

INTERNATIONAL SEARCH REPORT

Information on patent family members

International application No

PCT/IB2017/000699

Patent document cited in search report	Publication date	Patent family member(s)	Publication date
US 2016062549	A1	03-03-2016	CN 107111442 A 29-08-2017
		DE 112015004010 T5 14-06-2017	
		GB 2544437 A 17-05-2017	
		TW 201610792 A 16-03-2016	
		US 2016062549 A1 03-03-2016	
		US 2016062550 A1 03-03-2016	
		WO 2016034947 A2 10-03-2016	
US 2014152624	A1	05-06-2014	CN 105247455 A 13-01-2016
		KR 20150109346 A 01-10-2015	
		TW 201428582 A 16-07-2014	
		US 2014152624 A1 05-06-2014	
		US 2016034095 A1 04-02-2016	
		US 2017269777 A1 21-09-2017	
		WO 2014083437 A2 05-06-2014	
WO 2014027241	A2	20-02-2014	CN 104641329 A 20-05-2015
		EP 2845082 A2 11-03-2015	
		JP 2015519649 A 09-07-2015	
		KR 20150056749 A 27-05-2015	
		WO 2014027241 A2 20-02-2014	
US 2012218229	A1	30-08-2012	US 2012218229 A1 30-08-2012
			US 2016026338 A1 28-01-2016
			US 2017131847 A1 11-05-2017
US 2016098152	A1	07-04-2016	NONE
CN 101414225	A	22-04-2009	NONE